



5G Verification Source 10 GHz - SN: 1053

October 1, 2025

DASY Report

Measurement Report for 5G Verification Source 10 GHz, UID 0 --, Channel 10000.0 (10000.0 MHz)

Device Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
5G Verification Source 10 GHz	100.0 x 100.0 x 172.0	SN: 1053	--

Exposure Conditions

Phantom Section	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor
5G --	10.0 mm	Validation band	CW, 0--	10000.0,10000	1.0

Hardware Setup

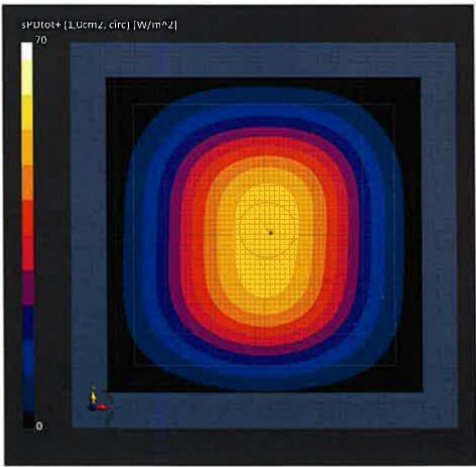
Phantom	Medium	Probe, Calibration Date	DAE, Calibration Date
mmWave Phantom --	Air --	EUmmWV3 - SN9374_F1-55GHz, 2025-08-26	DAE4ip - SN1602, 2024-11-06

Scans Setup

Sensor Surface [mm]	10.0
MAIA	MAIA not used

Measurement Results

Scan Type	5G Scan
Date	2025-10-01
Avg. Area [cm ²]	1.00
Avg. Type	Circular Averaging
psPDn+ [W/m ²]	57.4
psPDtot+ [W/m ²]	57.6
psPDmod+ [W/m ²]	57.7
Max(Sn) [W/m ²]	58.7
Max(Stot) [W/m ²]	58.8
Max(Stot) [W/m ²]	58.9
E _{max} [V/m]	149
Power Drift [dB]	0.0





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Device Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
5G Verification Source 10 GHz	100.0 x 100.0 x 172.0	SN: 1053	-

Exposure Conditions

Phantom Section	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor
5G --	10.0 mm	Validation band	CW, 0--	10000.0,10000	1.0

Hardware Setup

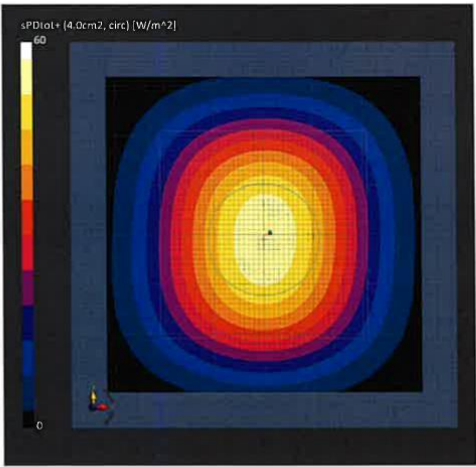
Phantom	Medium	Probe, Calibration Date	DAE, Calibration Date
mmWave Phantom --	Air --	EUmmWV3 -- SN9374_F1 -- 55GHz, 2025-08-26	DAE4ip -- SN1602, 2024-11-06

Scans Setup

Sensor Surface [mm]	10.0
MAIA	MAIA not used

Measurement Results

Scan Type	5G Scan
Date	2025-10-01
Avg. Area [cm ²]	4.00
Avg. Type	Circular Averaging
psPDn+ [W/m ²]	53.9
psPDtot+ [W/m ²]	54.2
psPDmod+ [W/m ²]	54.3
Max(Sn) [W/m ²]	58.7
Max(Stot) [W/m ²]	58.8
Max([Stot]) [W/m ²]	58.9
E _{max} [V/m]	149
Power Drift [dB]	0.0





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Device Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
5G Verification Source 10 GHz	100.0 x 100.0 x 172.0	SN: 1053	-

Exposure Conditions

Phantom Section	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor
5G -	10.0 mm	Validation band	CW, 0---	10000.0,10000	1.0

Hardware Setup

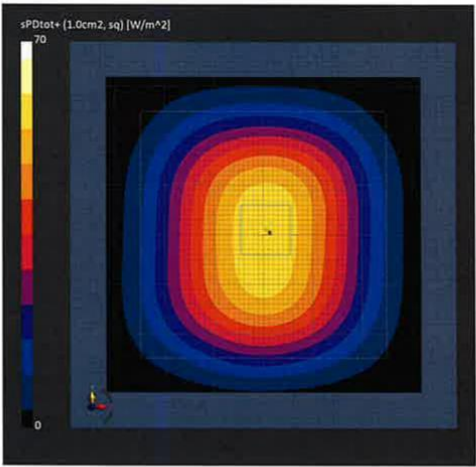
Phantom	Medium	Probe, Calibration Date	DAE, Calibration Date
mmWave Phantom -	Air -	EUmWV3 - SN9374_F1-55GHz, 2025-08-26	DAE4ip - SN1602, 2024-11-06

Scans Setup

Sensor Surface [mm]	10.0
MAIA	MAIA not used

Measurement Results

Scan Type	5G Scan
Date	2025-10-01
Avg. Area [cm ²]	1.00
Avg. Type	Square Averaging
psPDn+ [W/m ²]	57.4
psPDtot+ [W/m ²]	57.5
psPDmod+ [W/m ²]	57.7
Max(Sn) [W/m ²]	58.7
Max(Stot) [W/m ²]	58.8
Max(Stot) [W/m ²]	58.9
E _{max} [V/m]	149
Power Drift [dB]	0.0





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October 1, 2025

DASY Report

Measurement Report for 5G Verification Source 10 GHz, UID 0 --, Channel 10000.0 (10000.0 MHz)

Device Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
5G Verification Source 10 GHz	100.0 x 100.0 x 172.0	SN: 1053	-

Exposure Conditions

Phantom Section	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor
5G --	10.0 mm	Validation band	CW, 0---	10000.0,10000	1.0

Hardware Setup

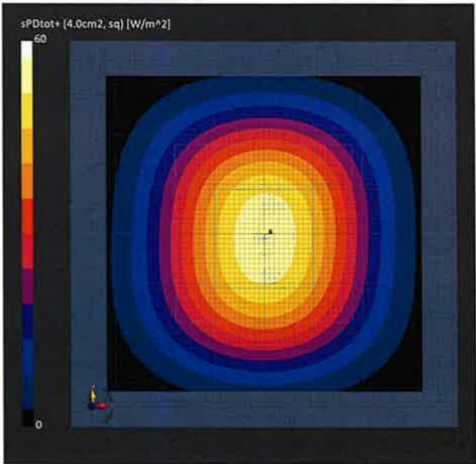
Phantom	Medium	Probe, Calibration Date	DAE, Calibration Date
mmWave Phantom --	Air --	EJmmWV3 -- SN9374_F1--55GHz, 2025-08-26	DAE4ip -- SN1602, 2024-11-06

Scans Setup

Sensor Surface [mm]	10.0
MAIA	MAIA not used

Measurement Results

Scan Type	5G Scan
Date	2025-10-01
Avg. Area [cm ²]	4.00
Avg. Type	Square Averaging
psPDn+ [W/m ²]	53.8
psPDtot+ [W/m ²]	54.1
psPDmod+ [W/m ²]	54.3
Max(Sn) [W/m ²]	58.7
Max(Stot) [W/m ²]	58.8
Max(Stot) [W/m ²]	58.9
E _{max} [V/m]	149
Power Drift [dB]	0.0





Signature: 

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ANNEX C

SAR Plots



Measurement Report for A3375, BACK, ISM 2.4 GHz Band, Bluetooth: BR, DH5, GFSK, Channel 39 (2441.000 MHz)

Equipment Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	EUT Type
A3375,	316.0 x 220.0 x 15.0		Laptop

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 5.00	ISM 2.4 GHz Band	Bluetooth, 10032-	2441.000, 39	6.9	1.66	40.8

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2202	HBBL-600-10000 DAK 3.5 Head 20.13 deg.C 2026-Sep-04 SYS5 B9.prn, 2026-09-04	EX3DV4 - SN3759, 2025-12-04	DAE4ip Sn1785, 2026-02-09

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	130.0 x 170.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	Y	Y
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-09-05, 14:19	2026-09-05, 14:27
psSAR1g [W/kg]	0.052	0.055
psSAR10g [W/kg]	0.027	0.030
Power Drift [dB]	0.15	0.17
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only
M2/M1 [%]		82.8
Dist 3dB Peak [mm]		13.2

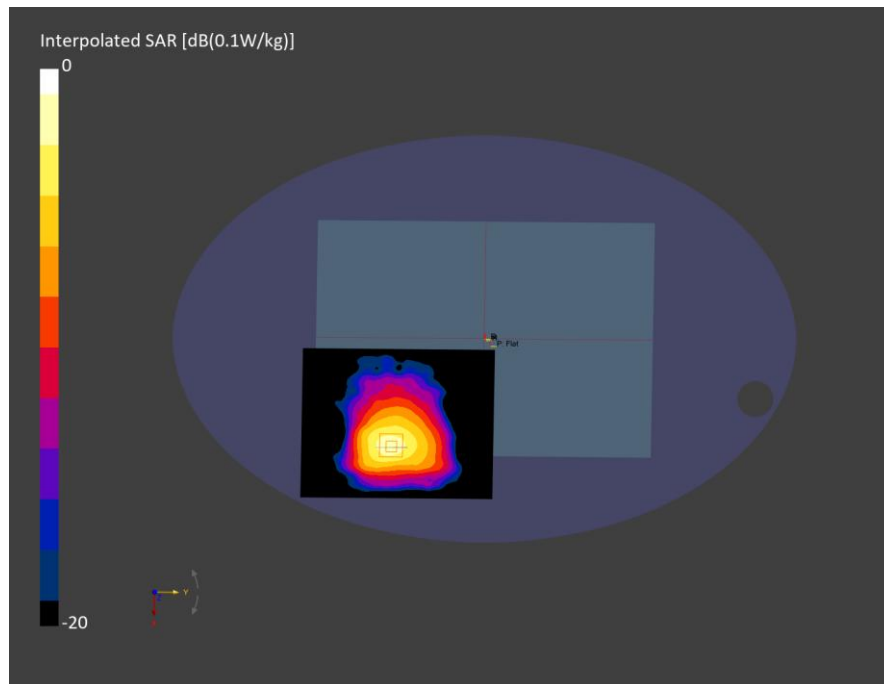


Figure C.1: Testing results for the A3375 at 2441.000 MHz



Measurement Report for A3375, BACK, ISM 2.4 GHz Band, Bluetooth: BR, DH5, GFSK, Channel 39 (2441.000 MHz)

Equipment Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	EUT Type
A3375,	316.0 x 220.0 x 15.0		Laptop

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 5.00	ISM 2.4 GHz Band	Bluetooth, 10032-	2441.000, 39	6.9	1.66	40.8

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2202	HBBL-600-10000 DAK 3.5 Head 20.13 deg.C 2026-Sep-04 SYS5 B9.prn, 2026-09-04	EX3DV4 - SN3759, 2025-12-04	DAE4ip Sn1785, 2026-02-09

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	130.0 x 170.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	Y	Y
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-09-05, 13:21	2026-09-05, 13:30
psSAR1g [W/kg]	0.040	0.040
psSAR10g [W/kg]	0.021	0.022
Power Drift [dB]	-0.04	-0.00
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only
M2/M1 [%]		82.6
Dist 3dB Peak [mm]		13.4

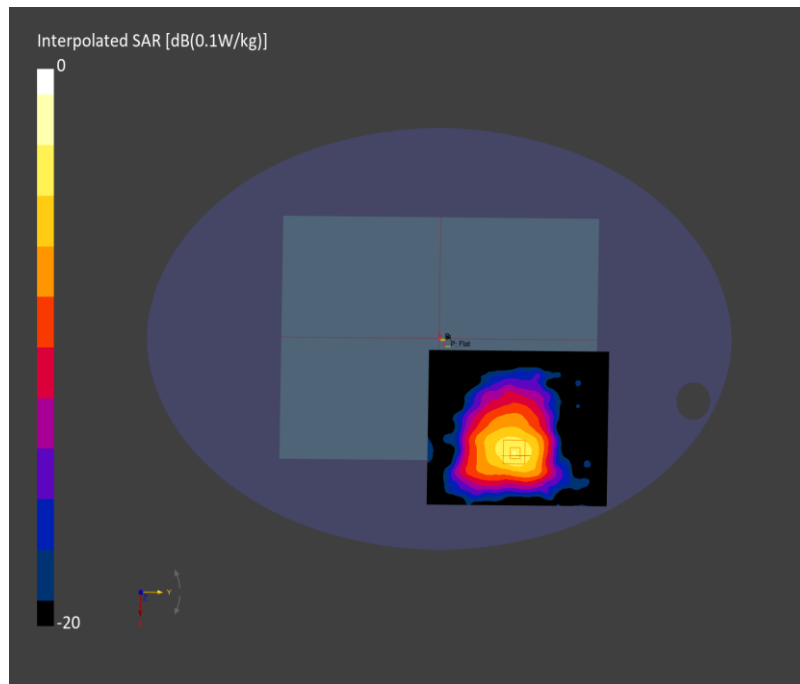


Figure C.2: Testing results for the A3375 at 2441.000 MHz



Measurement Report for A3375, BACK, ISM 2.4 GHz Band, Bluetooth: BR, DH5, GFSK, Channel 78 (2480.000 MHz)

Equipment Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	EUT Type
A3375,	316.0 x 220.0 x 15.0		Laptop

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 5.00	ISM 2.4 GHz Band	Bluetooth, 10032-	2480.000, 78	6.9	1.70	40.8

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2202	HBBL-600-10000 DAK 3.5 Head 20.13 deg.C 2026-Sep-04 SYS5 B9.prn, 2026-09-04	EX3DV4 - SN3759, 2025-12-04	DAE4ip Sn1785, 2026-02-09

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	130.0 x 150.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	Y	Y
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-09-05, 12:05	2026-09-05, 12:13
psSAR1g [W/kg]	0.021	0.021
psSAR10g [W/kg]	0.010	0.010
Power Drift [dB]	-0.07	0.07
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only
M2/M1 [%]		84.4
Dist 3dB Peak [mm]		12.0

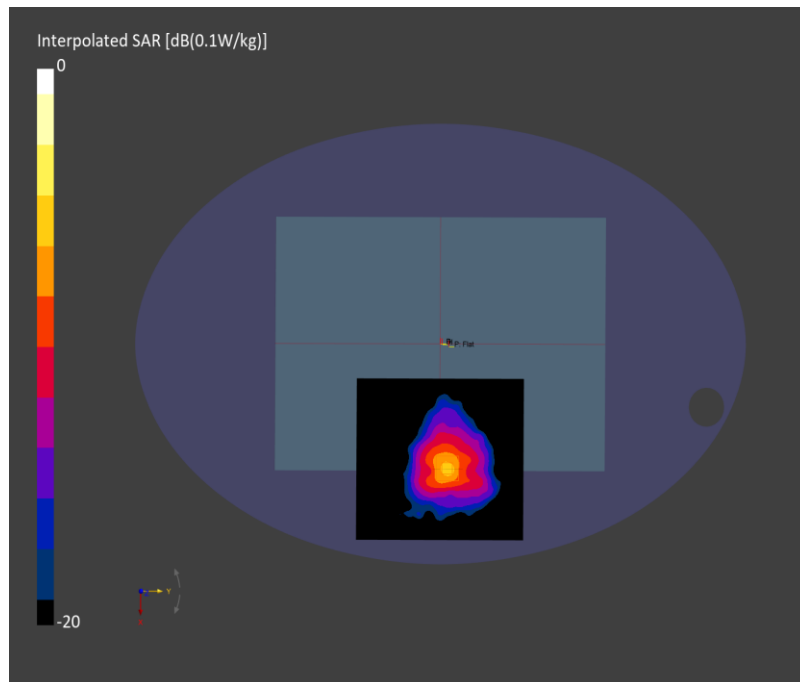


Figure C.3: Testing results for the A3375 at 2480.000 MHz



Measurement Report for A3375, BACK, Custom Band, CW, Channel 2440000 (2440.000 MHz)

Equipment Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	EUT Type
A3375,	316.0 x 220.0 x 15.0		Laptop

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 5.00	Custom Band	CW, 0-	2440.000, 2440000	7.54	1.68	40.6

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2102	HBBL-600-10000 DAK 3.5 Head 21.12 deg.C 2026-Sep-08 SYS3 B11.prn, 2026-09-08	EX3DV4 - SN7804, 2026-08-10	DAE4ip Sn1786, 2026-07-31

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 160.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	Y	Y
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-09-08, 14:02	2026-09-08, 14:10
psSAR1g [W/kg]	0.088	0.096
psSAR10g [W/kg]	0.047	0.053
Power Drift [dB]	0.01	0.13
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only
M2/M1 [%]		83.9
Dist 3dB Peak [mm]		12.4

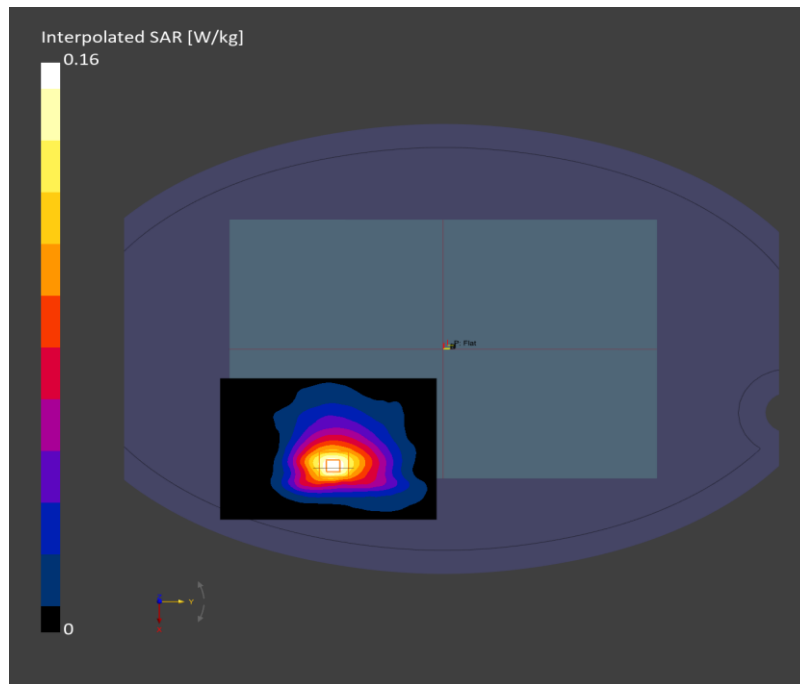


Figure C.4: Testing results for the A3375 at 2440.000 MHz



Measurement Report for A3375, BACK, Custom Band, CW, Channel 2480000 (2480.000 MHz)

Equipment Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	EUT Type
A3375,	316.0 x 220.0 x 15.0		Laptop

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 5.00	Custom Band	CW, 0-	2480.000, 2480000	7.54	1.71	40.6

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2102	HBBL-600-10000 DAK 3.5 Head 21.12 deg.C 2026-Sep-08 SYS3 B11.prn, 2026-09-08	EX3DV4 - SN7804, 2026-08-10	DAE4ip Sn1786, 2026-07-31

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 160.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	Y	Y
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-09-08, 15:17	2026-09-08, 15:26
psSAR1g [W/kg]	0.081	0.083
psSAR10g [W/kg]	0.043	0.045
Power Drift [dB]	-0.11	-0.07
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only
M2/M1 [%]		84.3
Dist 3dB Peak [mm]		13.0

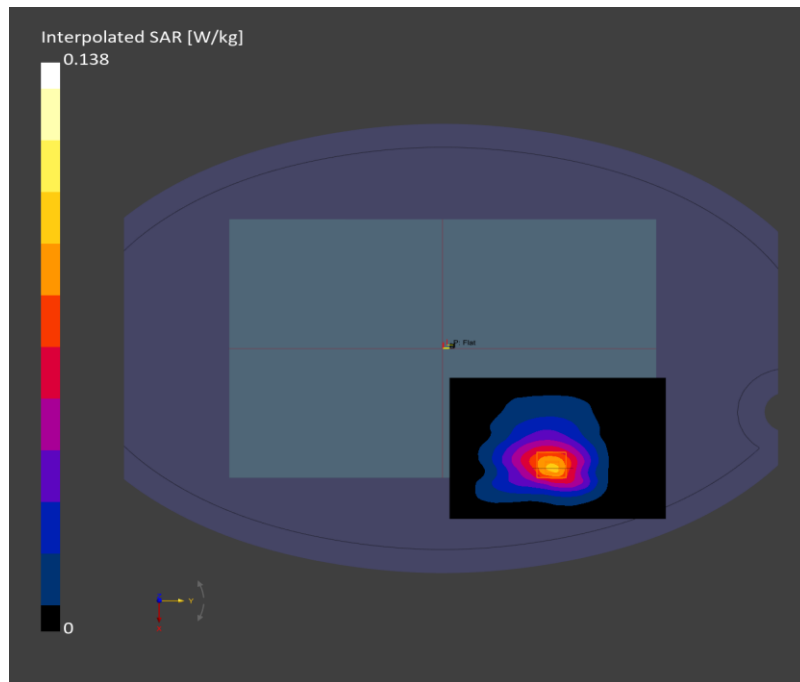


Figure C.5: Testing results for the A3375 at 2480.000 MHz



Measurement Report for A3375, BACK, Custom Band, CW, Channel 2440000 (2440.000 MHz)

Equipment Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	EUT Type
A3375,	316.0 x 220.0 x 15.0		Laptop

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 5.00	Custom Band	CW, 0--	2440.000, 2440000	7.54	1.68	39.7

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2102	HBBL-600-10000 DAK 3.5 Head 20.13 deg.C 2026-Sep-06 SYS3 B11, 2026-09-06	EX3DV4 - SN7804, 2026-08-10	DAE4ip Sn1786, 2026-07-31

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	130.0 x 170.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	Y	Y
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-09-07, 20:08	2026-09-07, 20:17
psSAR1g [W/kg]	0.022	0.021
psSAR10g [W/kg]	0.011	0.010
Power Drift [dB]	-0.29	-0.12
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only
M2/M1 [%]		82.4
Dist 3dB Peak [mm]		10.7

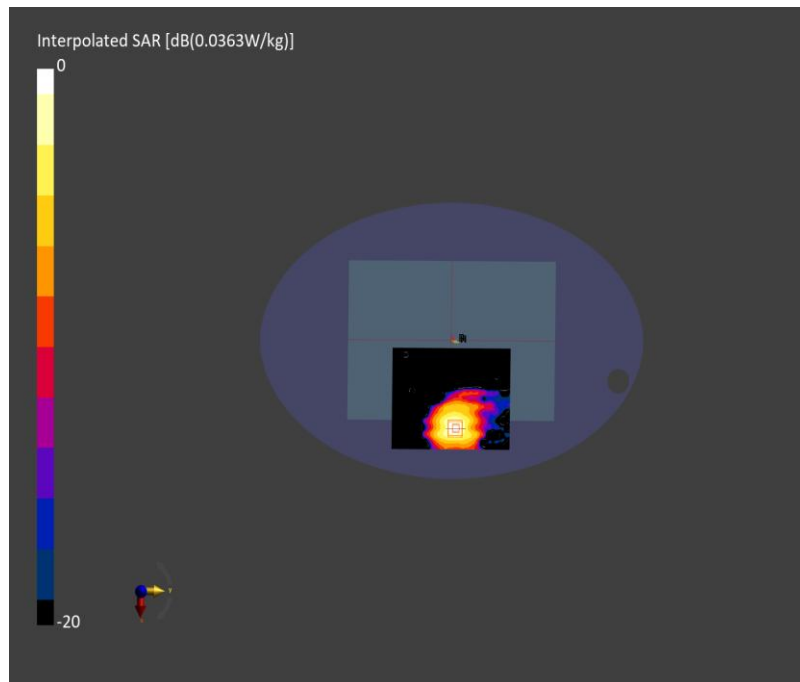


Figure C.6: Testing results for the A3375 at 2440.000 MHz



Measurement Report for A3375, BACK, Custom, Custom: NB, Channel 5250000 (5250.000 MHz)

Equipment Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	EUT Type
A3375,	316.0 x 220.0 x 15.0		Laptop

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 5.00	Custom	Custom, 10-	5250.000, 5250000	5.79	4.29	35.1

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2203	HBBL-600-10000 DAK 3.5 Head 19.66 deg.C 2026-Sep-06 SYS6 B10.prn, 2026-09-06	EX3DV4 - SN7809, 2026-05-11	DAE4ip Sn1789, 2026-05-08

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	130.0 x 170.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	Y	Y
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-09-07, 10:56	2026-09-07, 11:04
psSAR1g [W/kg]	0.087	0.094
psSAR10g [W/kg]	0.036	0.039
Power Drift [dB]	-0.19	-0.33
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only
M2/M1 [%]		64.5
Dist 3dB Peak [mm]		13.7

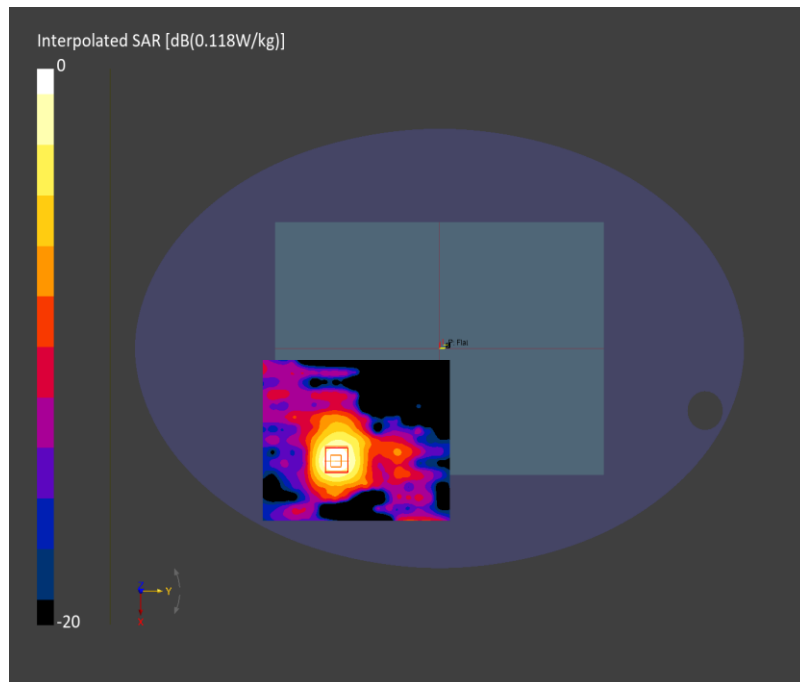


Figure C.7: Testing results for the A3375 at 5250.000 MHz



Measurement Report for A3375, BACK, Custom, Custom: NB, Channel 5150000 (5150.000 MHz)

Equipment Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	EUT Type
A3375,	316.0 x 220.0 x 15.0		Laptop

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 5.00	Custom	Custom, 10-	5150.000, 5150000	5.79	4.26	36.2

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2203	HBBL-600-10000 DAK 3.5 Head 19.69 deg.C 2026-Sep-08 SYS6 B10.prn, 2026-09-08	EX3DV4 - SN7809, 2026-05-11	DAE4ip Sn1789, 2026-05-08

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	130.0 x 170.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	Y	Y
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-09-08, 11:55	2026-09-08, 12:03
psSAR1g [W/kg]	0.096	0.097
psSAR10g [W/kg]	0.040	0.037
Power Drift [dB]	-0.45	-0.49
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only
M2/M1 [%]		64.5
Dist 3dB Peak [mm]		12.5

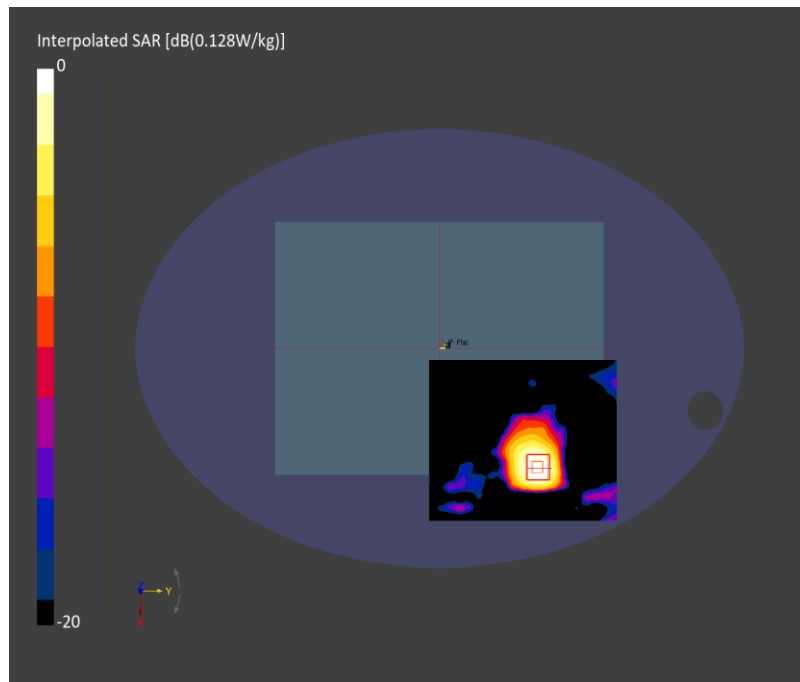


Figure C.8: Testing results for the A3375 at 5150.000 MHz



Measurement Report for A3375, BACK, Custom, Custom: Narrowband, Channel 5850000 (5850.000 MHz)

Equipment Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	EUT Type
A3375,	316.0 x 220.0 x 15.0		Laptop

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 5.00	Custom	Custom, 3-	5850.000, 5850000	5.06	4.94	34.1

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2203	HBBL-600-10000 DAK 3.5 Head 19.66 deg.C 2026-Sep-06 SYS6 B10.prn, 2026-09-06	EX3DV4 - SN7809, 2026-05-11	DAE4ip Sn1789, 2026-05-08

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	130.0 x 170.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-09-07, 13:46	2026-09-07, 13:53
psSAR1g [W/kg]	0.390	0.401
psSAR10g [W/kg]	0.154	0.159
Power Drift [dB]	-0.01	-0.10
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only
M2/M1 [%]		58.0
Dist 3dB Peak [mm]		12.7

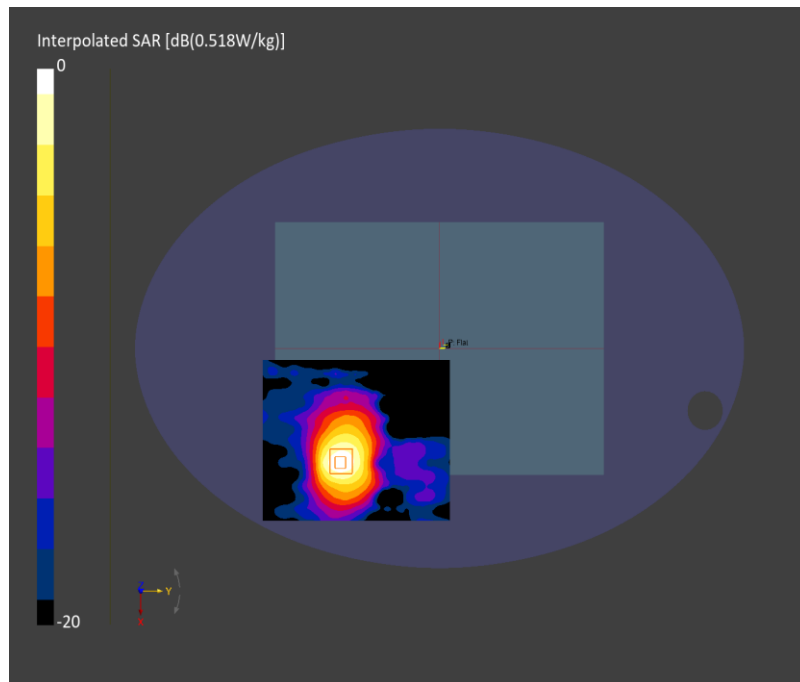


Figure C.9: Testing results for the A3375 at 5850.000 MHz



Measurement Report for A3375, BACK, Custom, Custom: Narrowband, Channel 5725000 (5725.000 MHz)

Equipment Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	EUT Type
A3375,	316.0 x 220.0 x 15.0		Laptop

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 5.00	Custom	Custom, 3-	5725.000, 5725000	5.06	4.80	34.3

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2203	HBBL-600-10000 DAK 3.5 Head 19.66 deg.C 2026-Sep-06 SYS6 B10.prn, 2026-09-06	EX3DV4 - SN7809, 2026-05-11	DAE4ip Sn1789, 2026-05-08

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	130.0 x 150.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-09-07, 16:58	2026-09-07, 17:06
psSAR1g [W/kg]	0.368	0.383
psSAR10g [W/kg]	0.150	0.153
Power Drift [dB]	-0.19	0.06
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only
M2/M1 [%]		58.6
Dist 3dB Peak [mm]		12.0

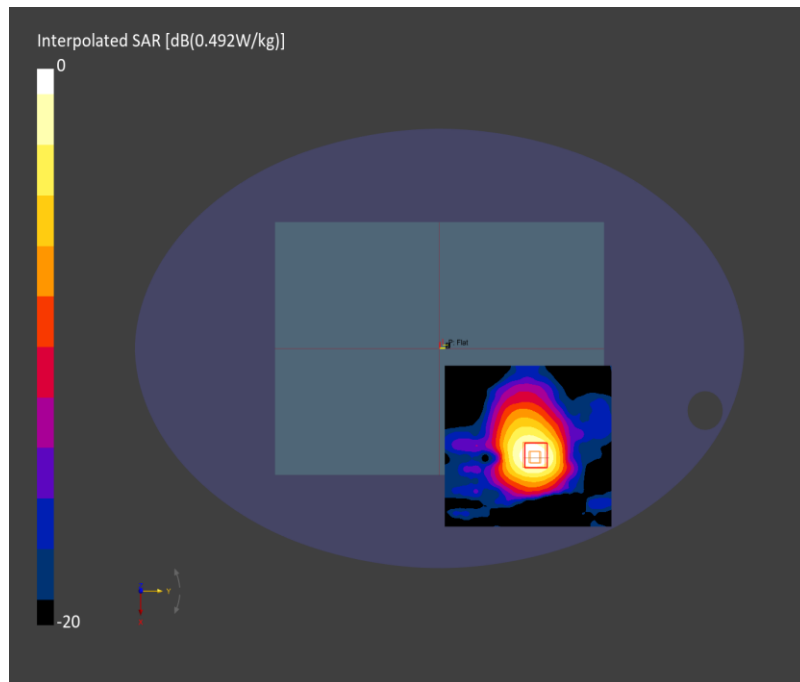


Figure C.10: Testing results for the A3375 at 5725.000 MHz



Measurement Report for A3375, BACK, Custom, Custom: Narrowband, Channel 5850000 (5850.000 MHz)

Equipment Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	EUT Type
A3375,	316.0 x 220.0 x 15.0		Laptop

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 5.00	Custom	Custom, 3-	5850.000, 5850000	5.06	4.94	34.1

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2203	HBBL-600-10000 DAK 3.5 Head 19.66 deg.C 2026-Sep-06 SYS6 B10.prn, 2026-09-06	EX3DV4 - SN7809, 2026-05-11	DAE4ip Sn1789, 2026-05-08

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	130.0 x 150.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	Y	Y
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-09-07, 20:25	2026-09-07, 20:33
psSAR1g [W/kg]	0.170	0.178
psSAR10g [W/kg]	0.069	0.071
Power Drift [dB]	-0.05	0.04
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only
M2/M1 [%]		57.4
Dist 3dB Peak [mm]		13.8

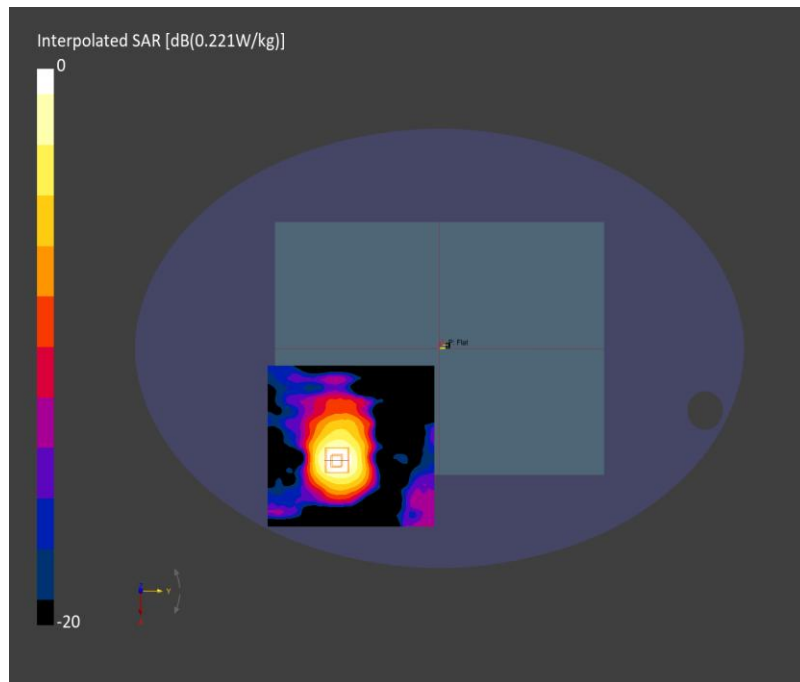


Figure C.11: Testing results for the A3375 at 5850.000 MHz



Measurement Report for A3375, BACK, Custom, Custom: Narrowband, Channel 5725000 (5725.000 MHz)

Equipment Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	EUT Type
A3375,	316.0 x 220.0 x 15.0		Laptop

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 5.00	Custom	Custom, 3-	5725.000, 5725000	5.06	4.80	34.3

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2203	HBBL-600-10000 DAK 3.5 Head 19.66 deg.C 2026-Sep-06 SYS6 B10.prn, 2026-09-06	EX3DV4 - SN7809, 2026-05-11	DAE4ip Sn1789, 2026-05-08

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	130.0 x 150.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-09-07, 21:15	2026-09-07, 21:23
psSAR1g [W/kg]	0.210	0.216
psSAR10g [W/kg]	0.085	0.087
Power Drift [dB]	-0.16	-0.23
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only
M2/M1 [%]		57.4
Dist 3dB Peak [mm]		13.2

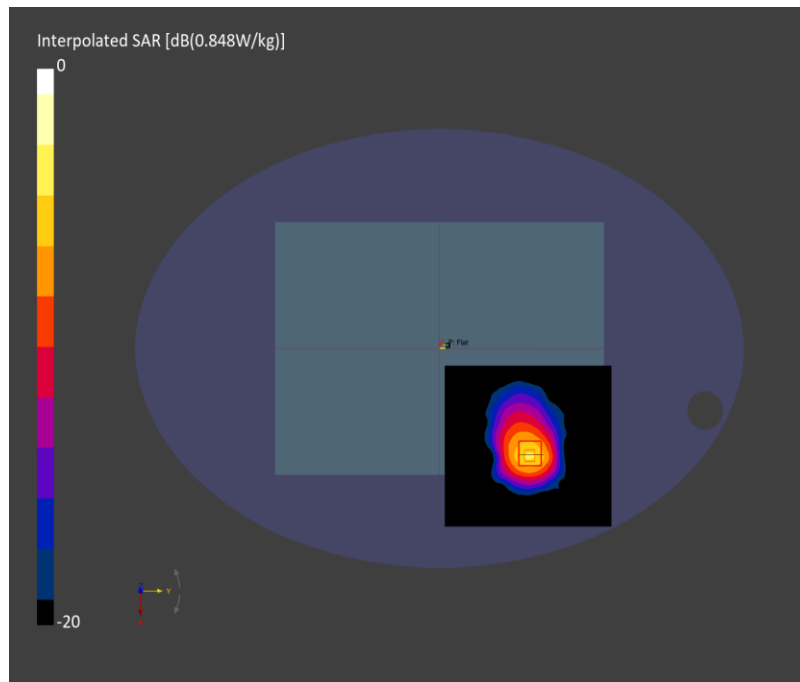


Figure C.12: Testing results for the A3375 at 5725.000 MHz



Measurement Report for A3375, BACK, 2.4 GHz, WiFi (802.11b): DSSS, DBPSK, 1.0 Mbps, 99.9% DC, Channel 6 (2437.000 MHz)

Equipment Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	EUT Type
A3375,	316.0 x 220.0 x 15.0		Laptop

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 5.00	2.4 GHz	WiFi (802.11b), 10415-	2437.000, 6	6.9	1.67	39.7

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2202	HBBL-600-10000 DAK 3.5 Head 18.38 deg.C 2026-Aug-21 SYS5 B9.prn, 2026-08-21	EX3DV4 - SN3759, 2025-12-04	DAE4ip Sn1785, 2026-02-09

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	130.0 x 170.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	Y	Y
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-08-22, 09:32	2026-08-22, 09:41
psSAR1g [W/kg]	0.115	0.119
psSAR10g [W/kg]	0.060	0.064
Power Drift [dB]	-0.01	-0.04
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only
M2/M1 [%]		77.1
Dist 3dB Peak [mm]		12.4

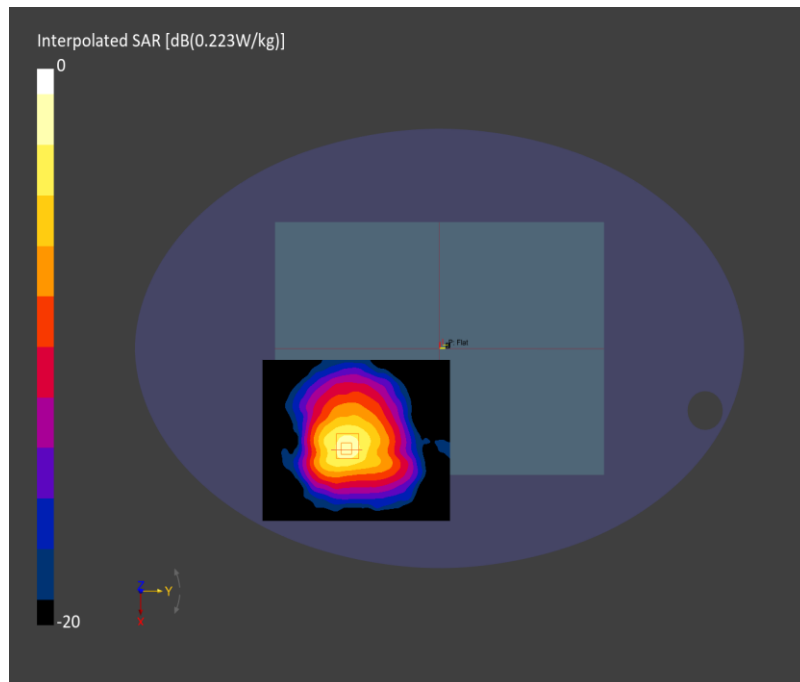


Figure C.13: Testing results for the A3375 at 2437.000 MHz



Measurement Report for A3375, BACK, 2.4 GHz, WiFi (802.11b): DSSS, DBPSK, 1.0 Mbps, 99.9% DC, Channel 6 (2437.000 MHz)

Equipment Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	EUT Type
A3375,	316.0 x 220.0 x 15.0		Laptop

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 5.00	2.4 GHz	WiFi (802.11b), 10415-	2437.000, 6	6.9	1.67	39.7

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2202	HBBL-600-10000 DAK 3.5 Head 18.38 deg.C 2026-Aug-21 SYS5 B9.prn, 2026-08-21	EX3DV4 - SN3759, 2025-12-04	DAE4ip Sn1785, 2026-02-09

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	130.0 x 170.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	Y	Y
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-08-22, 13:33	2026-08-22, 13:43
psSAR1g [W/kg]	0.097	0.100
psSAR10g [W/kg]	0.052	0.051
Power Drift [dB]	-0.08	0.03
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only
M2/M1 [%]		74.4
Dist 3dB Peak [mm]		4.0

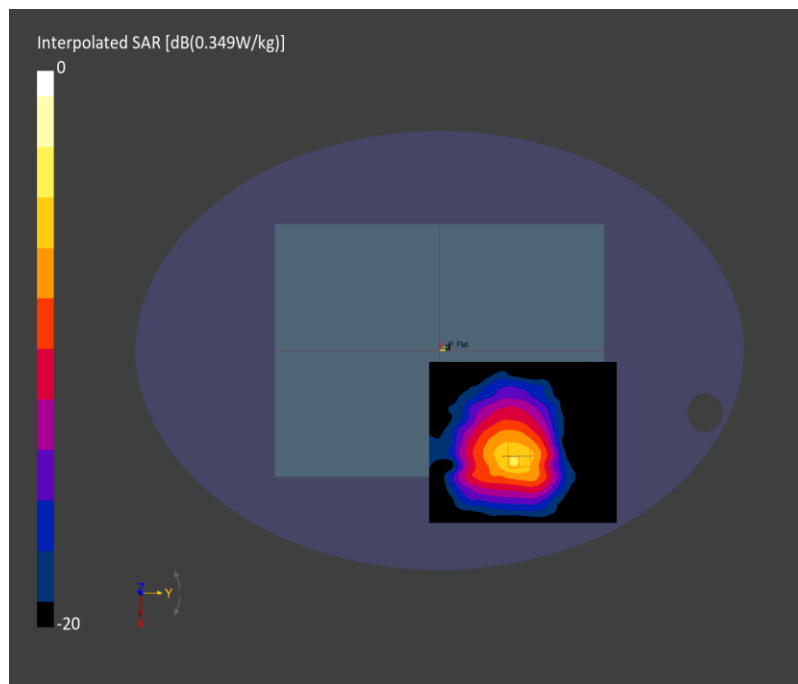


Figure C.14: Testing results for the A3375 at 2437.000 MHz



Measurement Report for A3375, BACK, 2.4 GHz, WiFi (802.11b): DSSS, DBPSK, 1.0 Mbps, 99.9% DC, Channel 6 (2437.000 MHz)

Equipment Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	EUT Type
A3375,	316.0 x 220.0 x 18.0		Laptop

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 5.00	2.4 GHz	WiFi (802.11b), 10415-	2437.000, 6	7.54	1.67	39.1

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2102	HBBL-600-10000 DAK 3.5 Head 20.67 deg.C 2026-Aug-23 SYS3 B11.prn, 2026-08-23	EX3DV4 - SN7804, 2026-08-10	DAE4ip Sn1786, 2026-07-31

Scans Setup

	Area Scan	Zoom Scan	Zoom Scan 2
Grid Extents [mm]	120.0 x 320.0	30.0 x 30.0 x 30.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4	1.4
Graded Grid	N/A	Yes	Yes
Grading Ratio	N/A	1.5	1.5
MAIA	Y	Y	Y
Surface Detection	VMS + 6p	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan	Zoom Scan 2
Date	2026-08-23, 11:12	2026-08-23, 11:20	2026-08-23, 11:29
psSAR1g [W/kg]	0.129	0.131	0.123
psSAR10g [W/kg]	0.069	0.071	0.068
Power Drift [dB]	-0.01	0.03	-0.08
Power Scaling	Disabled	Disabled	Disabled
Scaling Factor [dB]			
TSL Correction	Positive only	Positive only	Positive only
M2/M1 [%]		80.9	83.4
Dist 3dB Peak [mm]		12.0	13.0

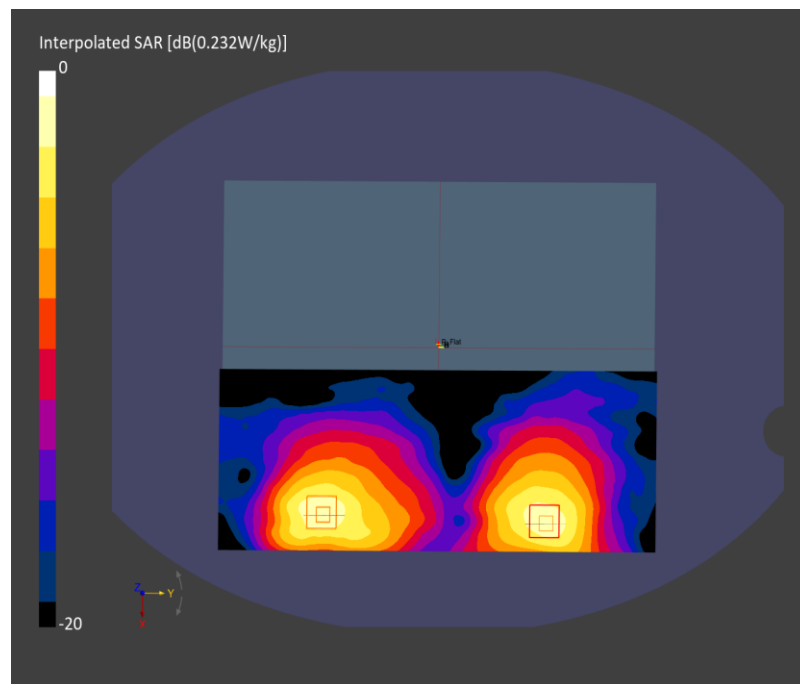


Figure C.15: Testing results for the A3375 at 2437.000 MHz



Measurement Report for A3375, BACK, 2.4 GHz, WiFi (802.11g): OFDM, BPSK, 6.0 Mbps, 99.9% DC, Channel 6 (2437.000 MHz)

Equipment Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	EUT Type
A3375,	316.0 x 220.0 x 15.0		Laptop

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 5.00	2.4 GHz	WiFi (802.11g), 10416-	2437.000, 6	6.9	1.67	39.7

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2202	HBBL-600-10000 DAK 3.5 Head 18.38 deg.C 2026-Aug-21 SYS5 B9.prn, 2026-08-21	EX3DV4 - SN3759, 2025-12-04	DAE4ip Sn1785, 2026-02-09

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	130.0 x 170.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	Y	Y
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-08-22, 11:19	2026-08-22, 11:28
psSAR1g [W/kg]	0.189	0.195
psSAR10g [W/kg]	0.101	0.107
Power Drift [dB]	0.11	0.10
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only
M2/M1 [%]		83.0
Dist 3dB Peak [mm]		14.0

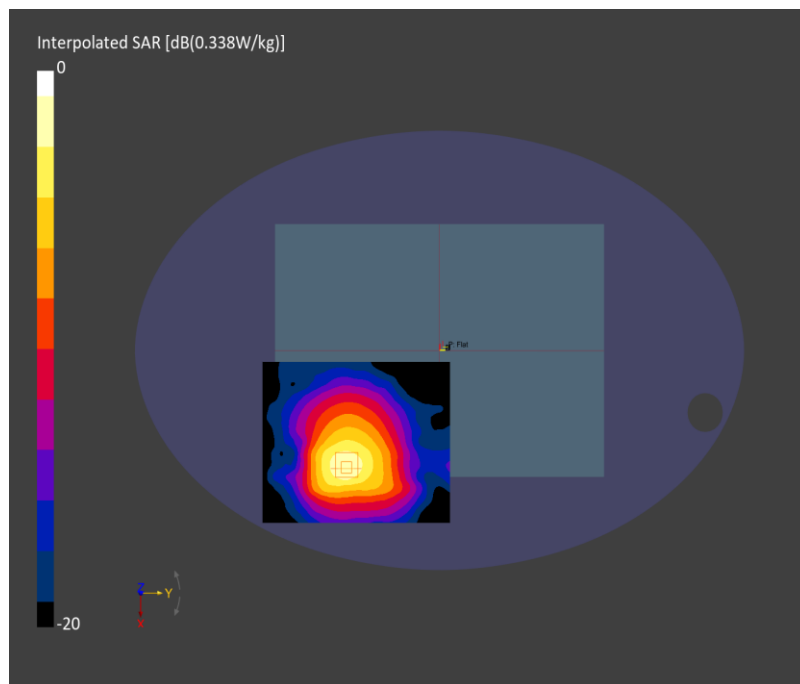


Figure C.16: Testing results for the A3375 at 2437.000 MHz



Measurement Report for A3375, BACK, 2.4 GHz, WiFi (802.11g): OFDM, BPSK, 6.0 Mbps, 99.9% DC, Channel 6 (2437.000 MHz)

Equipment Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	EUT Type
A3375,	316.0 x 220.0 x 15.0		Laptop

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 5.00	2.4 GHz	WiFi (802.11g), 10416-	2437.000, 6	6.9	1.67	40.9

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2202	HBBL-600-10000 DAK 3.5 Head 20.22 deg.C 2026-Aug-23 SYS5 B9.prn, 2026-08-23	EX3DV4 - SN3759, 2025-12-04	DAE4ip Sn1785, 2026-02-09

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	140.0 x 160.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	Y	Y
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-08-24, 00:59	2026-08-24, 01:07
psSAR1g [W/kg]	0.151	0.157
psSAR10g [W/kg]	0.082	0.085
Power Drift [dB]	-0.04	0.05
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only
M2/M1 [%]		81.5
Dist 3dB Peak [mm]		13.0

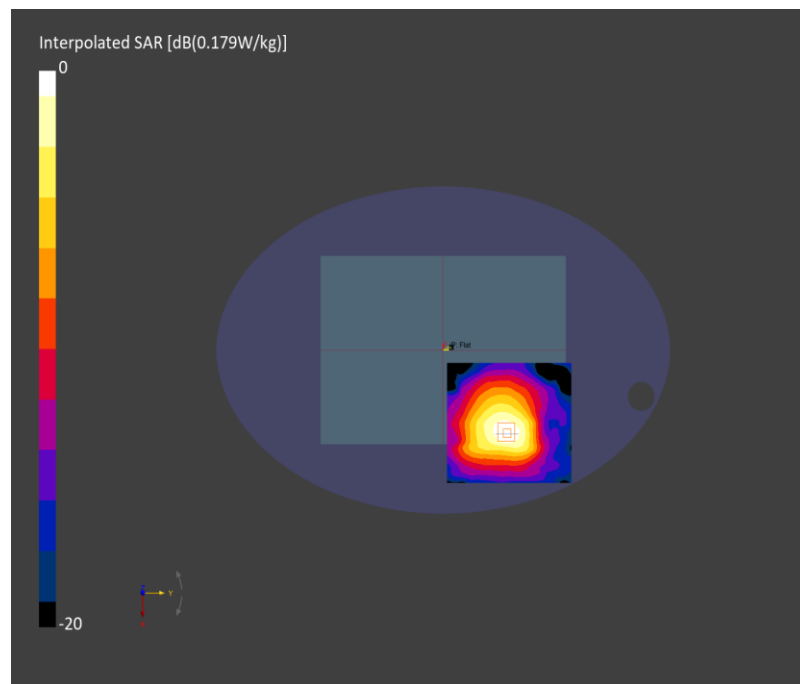


Figure C.17: Testing results for the A3375 at 2437.000 MHz



Measurement Report for A3375, BACK, 2.4 GHz, WiFi (802.11g): OFDM, BPSK, 6.0 Mbps, 99.9% DC, Channel 6 (2437.000 MHz)

Equipment Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	EUT Type
A3375,	316.0 x 220.0 x 18.0		Laptop

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 5.00	2.4 GHz	WiFi (802.11g), 10416-	2437.000, 6	7.54	1.67	39.1

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2102	HBBL-600-10000 DAK 3.5 Head 20.67 deg.C 2026-Aug-23 SYS3 B11.prn, 2026-08-23	EX3DV4 - SN7804, 2026-08-10	DAE4ip Sn1786, 2026-07-31

Scans Setup

	Area Scan	Zoom Scan	Zoom Scan 2
Grid Extents [mm]	120.0 x 300.0	30.0 x 30.0 x 30.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4	1.4
Graded Grid	N/A	Yes	Yes
Grading Ratio	N/A	1.5	1.5
MAIA	Y	Y	Y
Surface Detection	VMS + 6p	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan	Zoom Scan 2
Date	2026-08-23, 13:24	2026-08-23, 13:32	2026-08-23, 13:40
psSAR1g [W/kg]	0.160	0.162	0.130
psSAR10g [W/kg]	0.086	0.090	0.072
Power Drift [dB]	-0.00	-0.01	-0.05
Power Scaling	Disabled	Disabled	Disabled
Scaling Factor [dB]			
TSL Correction	Positive only	Positive only	Positive only
M2/M1 [%]		84.4	84.3
Dist 3dB Peak [mm]		13.7	15.0

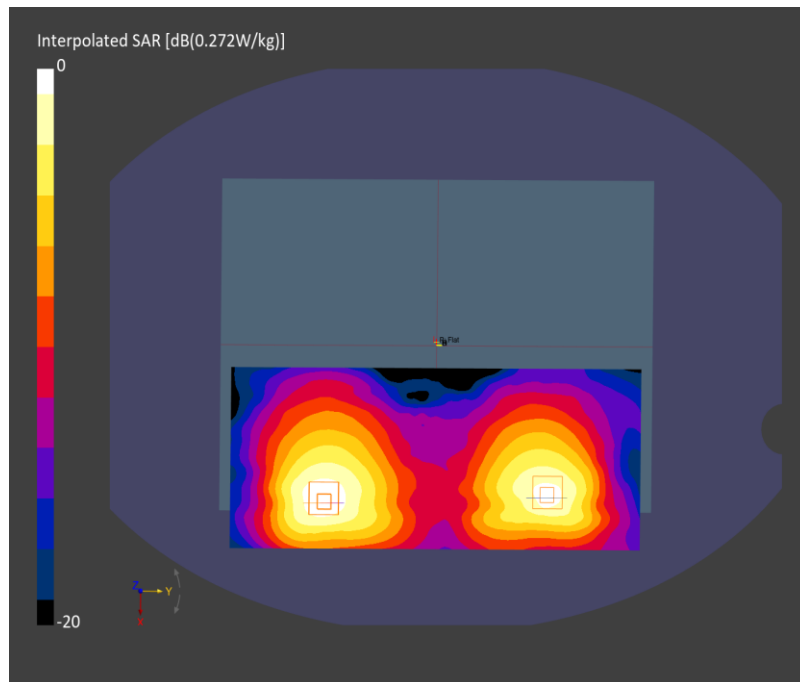


Figure C.18: Testing results for the A3375 at 2437.000 MHz



Measurement Report for A3375, BACK, U-NII 1 / 2A, WiFi (802.11n): HT40 Mixed, MCS0 (13.5 Mbps), 99.7% DC, Channel 46 (5230.000 MHz)

Equipment Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	EUT Type
A3375,	316.0 x 220.0 x 15.0		Laptop

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 5.00	U-NII 1 / 2A	WiFi (802.11n), 10117-	5230.000, 46	5.57	4.45	37.2

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2202	HBBL-600-10000 DAK 3.5 Head 20.00 deg.C 2026-Aug-25 SYS5 B9.prn, 2026-08-25	EX3DV4 - SN3759, 2025-12-04	DAE4ip Sn1785, 2026-02-09

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	150.0 x 170.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-08-26, 07:22	2026-08-26, 07:30
psSAR1g [W/kg]	0.627	0.645
psSAR10g [W/kg]	0.258	0.257
Power Drift [dB]	0.00	0.01
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only
M2/M1 [%]		63.0
Dist 3dB Peak [mm]		10.5

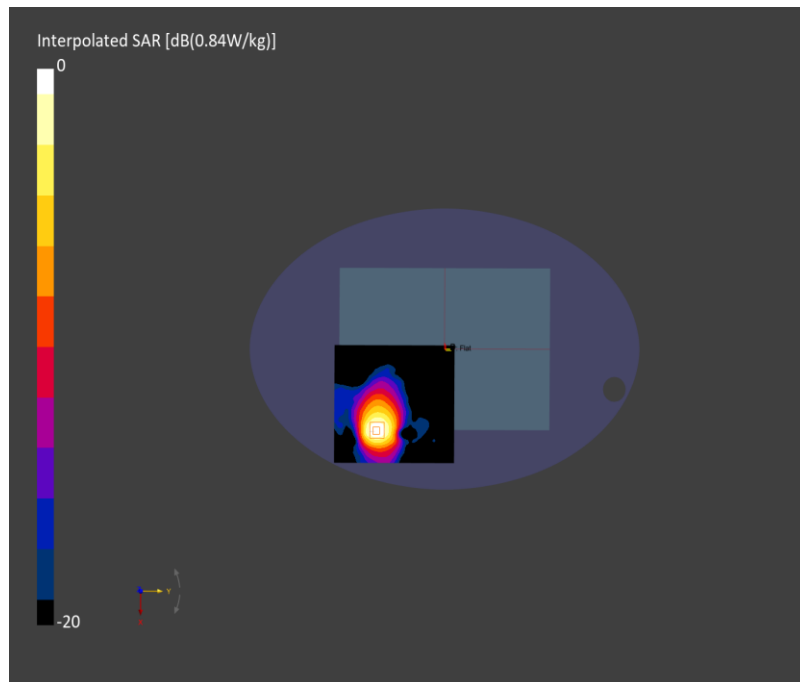


Figure C.19: Testing results for the A3375 at 5230.000 MHz



Measurement Report for A3375, BACK, U-NII 1 / 2A, WiFi (802.11a): OFDM, BPSK, 6.0 Mbps, 99.9% DC, Channel 40 (5200.000 MHz)

Equipment Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	EUT Type
A3375,	316.0 x 220.0 x 15.0		Laptop

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 5.00	U-NII 1 / 2A	WiFi (802.11a), 10417-	5200.000, 40	5.42	4.46	36.9

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2270	DAK 3.5 Head 18.99 deg.C 2026-Aug-25 SYS4 B8 DAK 3.5 Head 18.99 deg.C 2026-Aug-25 SYS4 B8.prn, 2026-08-25	EX3DV4 - SN7973, 2026-02-24	DAE4ip Sn1935, 2026-02-18

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	150.0 x 170.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-08-26, 11:15	2026-08-26, 11:22
psSAR1g [W/Kg]	0.505	0.519
psSAR10g [W/Kg]	0.208	0.213
Power Drift [dB]	0.05	-0.03
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only
M2/M1 [%]		63.9
Dist 3dB Peak [mm]		13.4

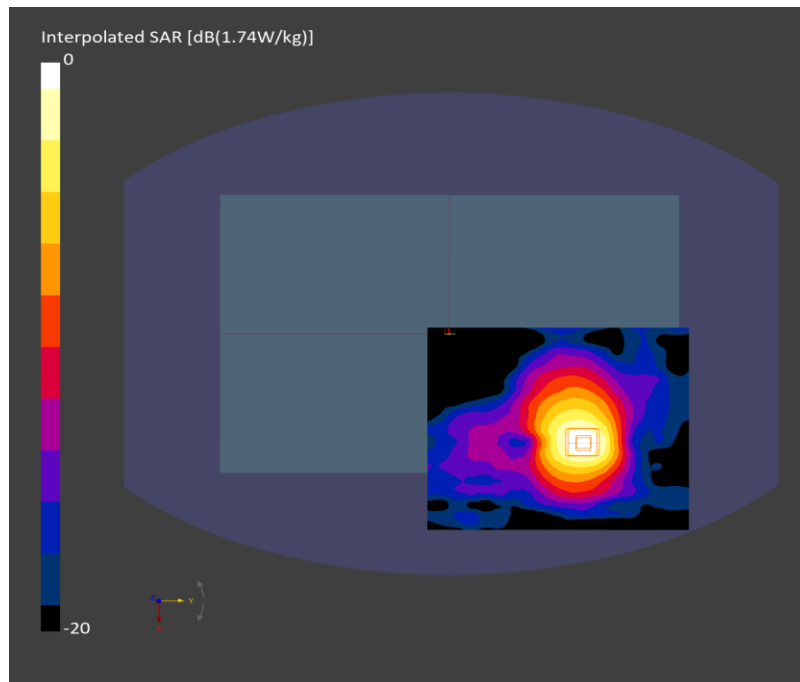


Figure C.20: Testing results for the A3375 at 5200.000 MHz



Measurement Report for A3375, BACK, U-NII 1 / 2A, WiFi (802.11n): HT40 Mixed, MCS0 (13.5 Mbps), 99.7% DC, Channel 46 (5230.000 MHz)

Equipment Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	EUT Type
A3375,	316.0 x 220.0 x 15.0		Laptop

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 5.00	U-NII 1 / 2A	WiFi (802.11n), 10117-	5230.000, 46	5.42	4.50	36.8

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2270	DAK 3.5 Head 18.99 deg.C 2026-Aug-25 SYS4 B8 , 2026-08-26	EX3DV4 - SN7973, 2026-02-24	DAE4ip Sn1935, 2026-02-18

Scans Setup

	Area Scan	Zoom Scan	Zoom Scan 2
Grid Extents [mm]	130.0 x 300.0	22.0 x 22.0 x 22.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4	1.4
Graded Grid	N/A	Yes	Yes
Grading Ratio	N/A	1.4	1.4
MAIA	N/A	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan	Zoom Scan 2
Date	2026-08-27, 05:30	2026-08-27, 05:42	2026-08-27, 05:54
psSAR1g [W/Kg]	0.409	0.433	0.405
psSAR10g [W/Kg]	0.173	0.177	0.164
Power Drift [dB]	-0.05	-0.13	-0.08
Power Scaling	Disabled	Disabled	Disabled
Scaling Factor [dB]			
TSL Correction	Positive only	Positive only	Positive only
M2/M1 [%]		63.3	63.0
Dist 3dB Peak [mm]		12.3	12.0

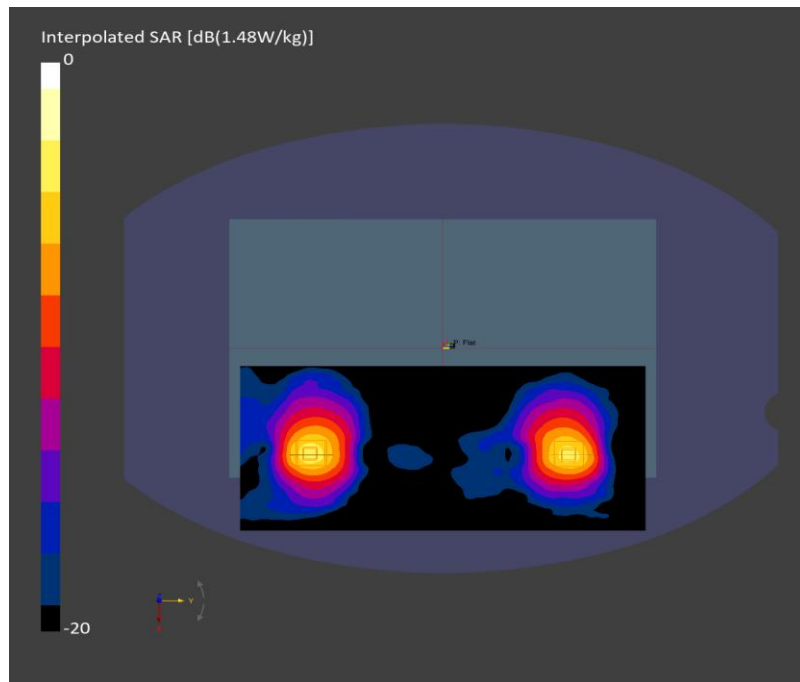


Figure C.21: Testing results for the A3375 at 5230.000 MHz



Measurement Report for A3375, BACK, U-NII 1 / 2A, WiFi (802.11n): HT40 Mixed, MCS0 (13.5 Mbps), 99.7% DC, Channel 54 (5270.000 MHz)

Equipment Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	EUT Type
A3375,	316.0 x 220.0 x 15.0		Laptop

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 5.00	U-NII 1 / 2A	WiFi (802.11n), 10117-	5270.000, 54	5.37	4.50	37.2

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2202	HBBL-600-10000 DAK 3.5 Head 20.00 deg.C 2026-Aug-25 SYS5 B9.prn, 2026-08-25	EX3DV4 - SN3759, 2025-12-04	DAE4ip Sn1785, 2026-02-09

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	150.0 x 170.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-08-26, 06:58	2026-08-26, 07:06
psSAR1g [W/kg]	0.598	0.614
psSAR10g [W/kg]	0.245	0.247
Power Drift [dB]	-0.04	0.04
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only
M2/M1 [%]		62.9
Dist 3dB Peak [mm]		11.2

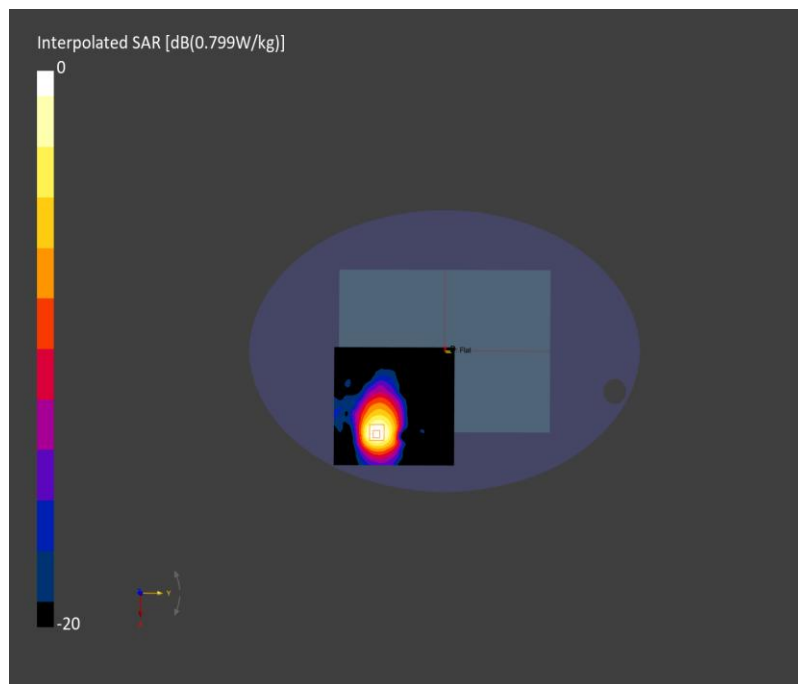


Figure C.22: Testing results for the A3375 at 5270.000 MHz



Measurement Report for A3375, BACK, U-NII 1 / 2A, WiFi (802.11n): HT40 Mixed, MCS0 (13.5 Mbps), 99.7% DC, Channel 54 (5270.000 MHz)

Equipment Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	EUT Type
A3375,	316.0 x 220.0 x 15.0		Laptop

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 5.00	U-NII 1 / 2A	WiFi (802.11n), 10117-	5270.000, 54	5.28	4.55	36.8

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2270	DAK 3.5 Head 18.99 deg.C 2026-Aug-25 SYS4 B8 DAK 3.5 Head 18.99 deg.C 2026-Aug-25 SYS4 B8.prn, 2026-08-25	EX3DV4 - SN7973, 2026-02-24	DAE4ip Sn1935, 2026-02-18

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	150.0 x 170.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-08-26, 13:30	2026-08-26, 13:37
psSAR1g [W/Kg]	0.483	0.499
psSAR10g [W/Kg]	0.198	0.204
Power Drift [dB]	0.02	0.02
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only
M2/M1 [%]		62.7
Dist 3dB Peak [mm]		13.2

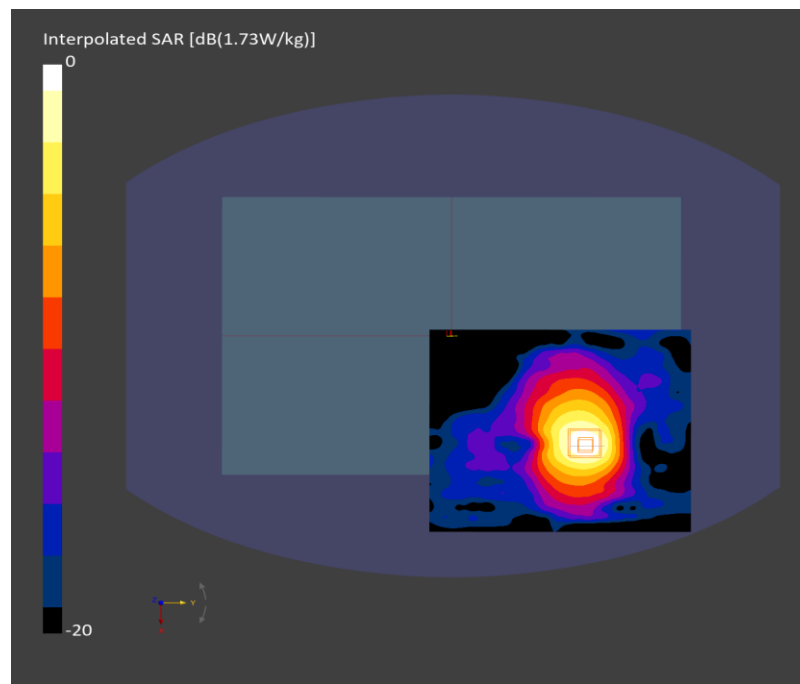


Figure C.23: Testing results for the A3375 at 5270.000 MHz



Measurement Report for A3375, BACK, U-NII 1 / 2A, WiFi (802.11n): HT40 Mixed, MCS0 (13.5 Mbps), 99.7% DC, Channel 54 (5270.000 MHz)

Equipment Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	EUT Type
A3375,	316.0 x 220.0 x 15.0		Laptop

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 5.00	U-NII 1 / 2A	WiFi (802.11n), 10117-	5270.000, 54	5.28	4.55	36.8

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2270	DAK 3.5 Head 18.99 deg.C 2026-Aug-25 SYS4 B8 , 2026-08-26	EX3DV4 - SN7973, 2026-02-24	DAE4ip Sn1935, 2026-02-18

Scans Setup

	Area Scan	Zoom Scan	Zoom Scan 2
Grid Extents [mm]	130.0 x 300.0	22.0 x 22.0 x 22.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4	1.4
Graded Grid	N/A	Yes	Yes
Grading Ratio	N/A	1.4	1.4
MAIA	N/A	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan	Zoom Scan 2
Date	2026-08-27, 06:08	2026-08-27, 06:20	2026-08-27, 06:32
psSAR1g [W/Kg]	0.429	0.450	0.402
psSAR10g [W/Kg]	0.181	0.185	0.163
Power Drift [dB]	0.06	-0.05	-0.03
Power Scaling	Disabled	Disabled	Disabled
Scaling Factor [dB]			
TSL Correction	Positive only	Positive only	Positive only
M2/M1 [%]		63.5	62.6
Dist 3dB Peak [mm]		12.2	11.7

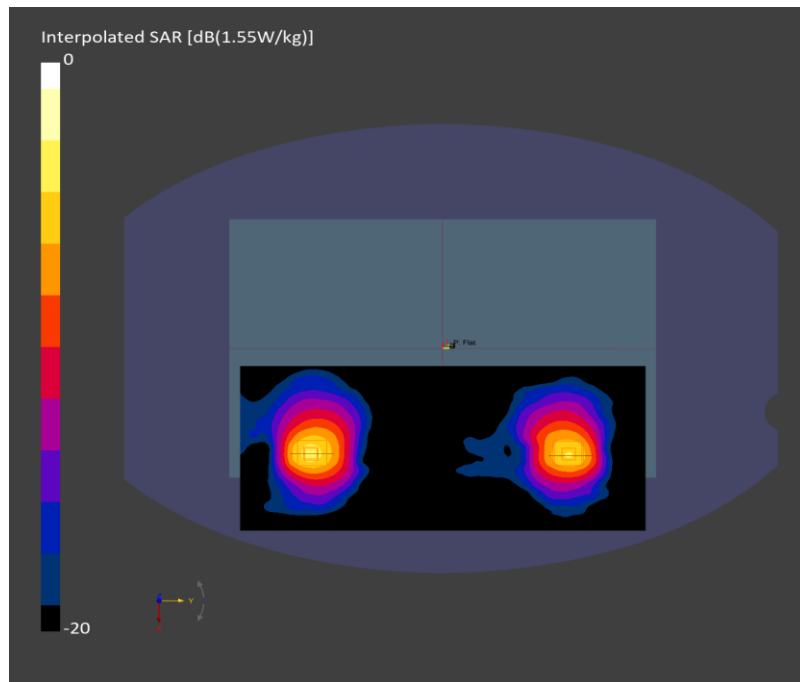


Figure C.24: Testing results for the A3375 at 5270.000 MHz



Measurement Report for A3375, BACK, U-NII 2C, WiFi (802.11ac): VHT80, MCS0 (29.3 Mbps), 99.0% DC, Channel 138 (5690.000 MHz)

Equipment Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	EUT Type
A3375,	316.0 x 220.0 x 15.0		Laptop

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 5.00	U-NII 2C	WiFi (802.11ac), 10544-	5690.000, 138	4.95	5.03	36.7

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2203	HBBL-600-10000 DAK 3.5 Head 20.18 deg.C 2026-Aug-25 SYS6 B10.prn, 2026-08-25	EX3DV4 - SN7809, 2026-05-11	DAE4ip Sn1789, 2026-05-08

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	150.0 x 170.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-08-26, 03:22	2026-08-26, 03:34
psSAR1g [W/kg]	0.657	0.678
psSAR10g [W/kg]	0.269	0.269
Power Drift [dB]	-0.10	-0.00
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only
M2/M1 [%]		58.6
Dist 3dB Peak [mm]		12.8

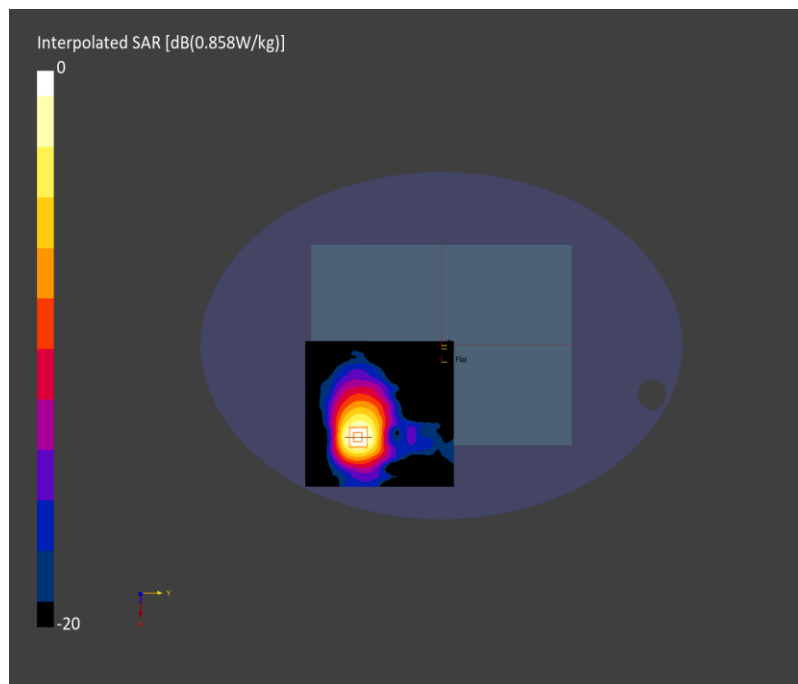


Figure C.25: Testing results for the A3375 at 5690.000 MHz



Measurement Report for A3375, BACK, U-NII 2C, WiFi (802.11ac): VHT80, MCS0 (29.3 Mbps), 99.0% DC, Channel 122 (5610.000 MHz)

Equipment Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	EUT Type
A3375,	316.0 x 220.0 x 15.0		Laptop

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 5.00	U-NII 2C	WiFi (802.11ac), 10544-	5610.000, 122	4.86	4.94	36.1

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2270	DAK 3.5 Head 18.99 deg.C 2026-Aug-25 SYS4 B8 , 2026-08-26	EX3DV4 - SN7973, 2026-02-24	DAE4ip Sn1935, 2026-02-18

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	130.0 x 170.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-08-26, 18:27	2026-08-26, 18:39
psSAR1g [W/Kg]	0.612	0.632
psSAR10g [W/Kg]	0.258	0.256
Power Drift [dB]	0.02	0.00
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only
M2/M1 [%]		59.1
Dist 3dB Peak [mm]		12.7

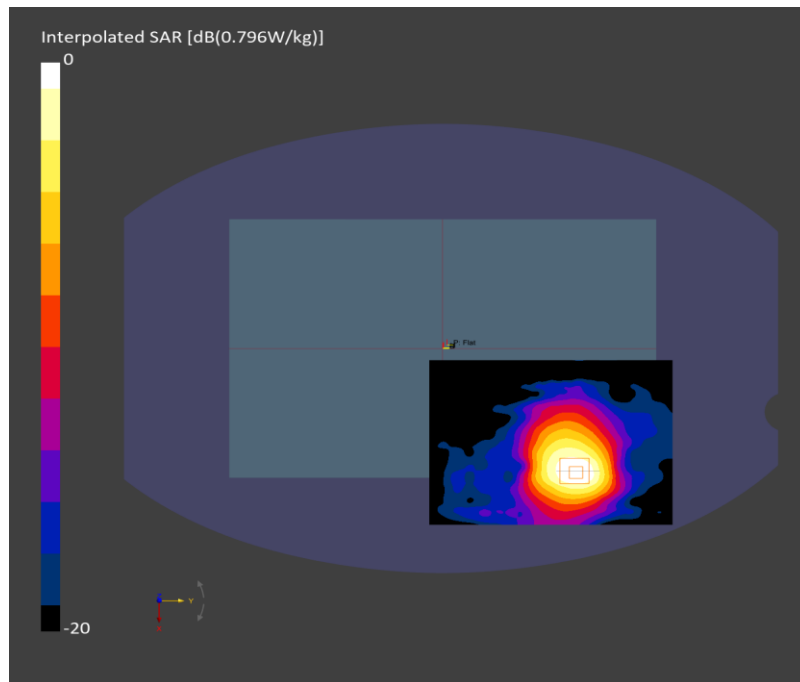


Figure C.26: Testing results for the A3375 at 5610.000 MHz



Measurement Report for A3375, BACK, U-NII 2C, WiFi (802.11n): HT40 Mixed, MCS0 (13.5 Mbps), 99.7% DC, Channel 110 (5550.000 MHz)

Equipment Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	EUT Type
A3375,	316.0 x 220.0 x 15.0		Laptop

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 5.00	U-NII 2C	WiFi (802.11n), 10117-	5550.000, 110	4.84	4.94	36.8

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2102	HBBL-600-10000 DAK 3.5 Head 19.90 deg.C 2026-Aug-27 SYS3 B11.prn, 2026-08-27	EX3DV4 - SN7804, 2026-08-10	DAE4ip Sn1786, 2026-07-31

Scans Setup

	Area Scan	Zoom Scan	Zoom Scan 2
Grid Extents [mm]	130.0 x 300.0	22.0 x 22.0 x 22.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4	1.4
Graded Grid	N/A	Yes	Yes
Grading Ratio	N/A	1.4	1.4
MAIA	N/A	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan	Zoom Scan 2
Date	2026-08-27, 23:18	2026-08-27, 23:30	2026-08-27, 23:39
psSAR1g [W/kg]	0.550	0.578	0.521
psSAR10g [W/kg]	0.228	0.233	0.207
Power Drift [dB]	-0.14	0.13	0.01
Power Scaling	Disabled	Disabled	Disabled
Scaling Factor [dB]			
TSL Correction	Positive only	Positive only	Positive only
M2/M1 [%]		60.3	60.3
Dist 3dB Peak [mm]		10.2	11.5

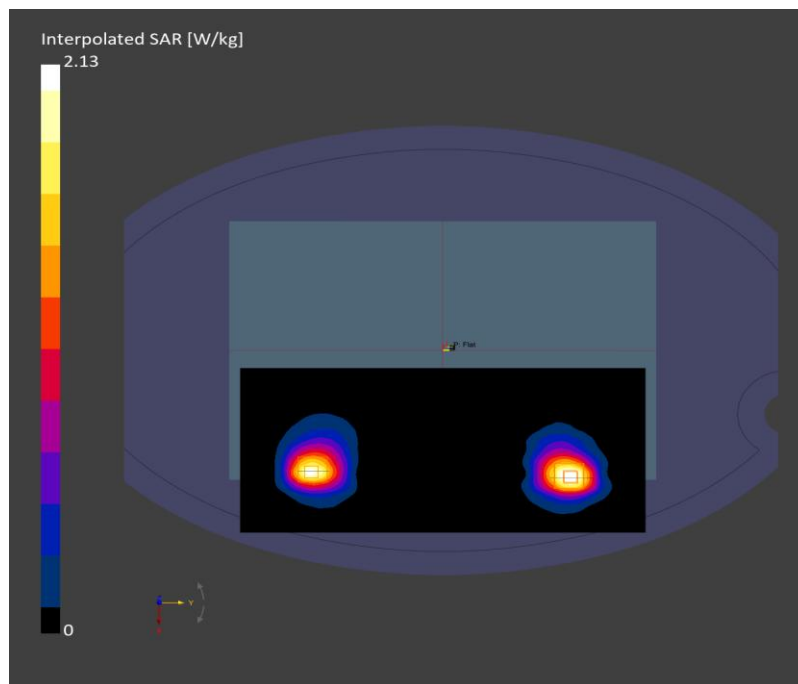


Figure C.27: Testing results for the A3375 at 5550.000 MHz



Measurement Report for A3375, BACK, U-NII 3, WiFi (802.11n): HT40 Mixed, MCS0 (13.5 Mbps), 99.7% DC, Channel 159 (5795.000 MHz)

Equipment Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	EUT Type
A3375,	316.0 x 220.0 x 15.0		Laptop

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 5.00	U-NII 3	WiFi (802.11n), 10117-	5795.000, 159	5.06	5.16	36.5

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2203	HBBL-600-10000 DAK 3.5 Head 20.18 deg.C 2026-Aug-25 SYS6 B10.prn, 2026-08-25	EX3DV4 - SN7809, 2026-05-11	DAE4ip Sn1789, 2026-05-08

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	150.0 x 170.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-08-26, 07:33	2026-08-26, 07:45
psSAR1g [W/kg]	0.671	0.704
psSAR10g [W/kg]	0.273	0.279
Power Drift [dB]	-0.04	-0.07
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only
M2/M1 [%]		57.4
Dist 3dB Peak [mm]		12.5

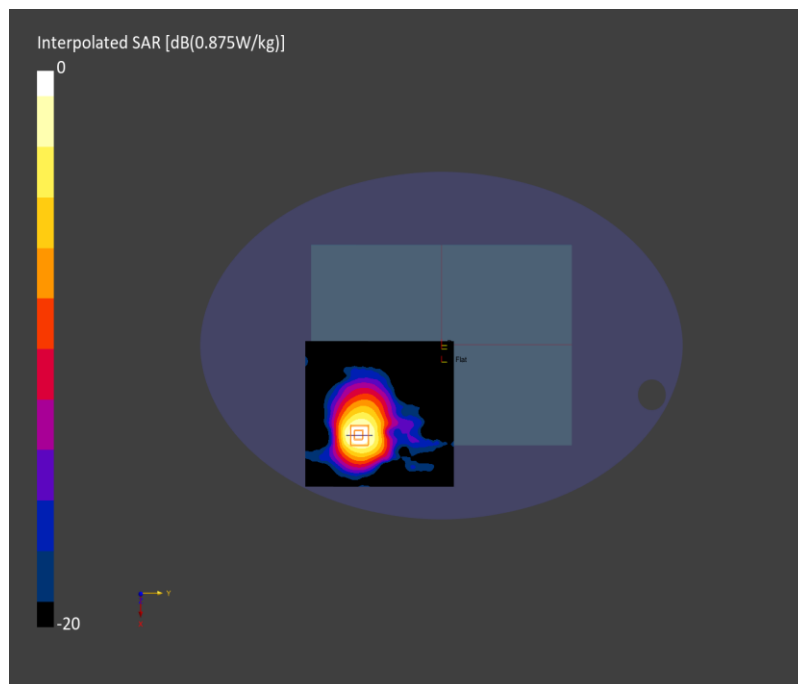


Figure C.28: Testing results for the A3375 at 5795.000 MHz



Measurement Report for A3375, BACK, U-NII 3, WiFi (802.11n): HT40 Mixed, MCS0 (13.5 Mbps), 99.7% DC, Channel 159 (5795.000 MHz)

Equipment Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	EUT Type
A3375,	316.0 x 220.0 x 15.0		Laptop

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 5.00	U-NII 3	WiFi (802.11n), 10117-	5795.000, 159	4.88	5.16	35.8

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2270	DAK 3.5 Head 18.99 deg.C 2026-Aug-25 SYS4 B8 , 2026-08-26	EX3DV4 - SN7973, 2026-02-24	DAE4ip Sn1935, 2026-02-18

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	130.0 x 170.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-08-26, 21:33	2026-08-26, 21:45
psSAR1g [W/Kg]	0.566	0.588
psSAR10g [W/Kg]	0.236	0.235
Power Drift [dB]	-0.00	0.09
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only
M2/M1 [%]		57.9
Dist 3dB Peak [mm]		11.2

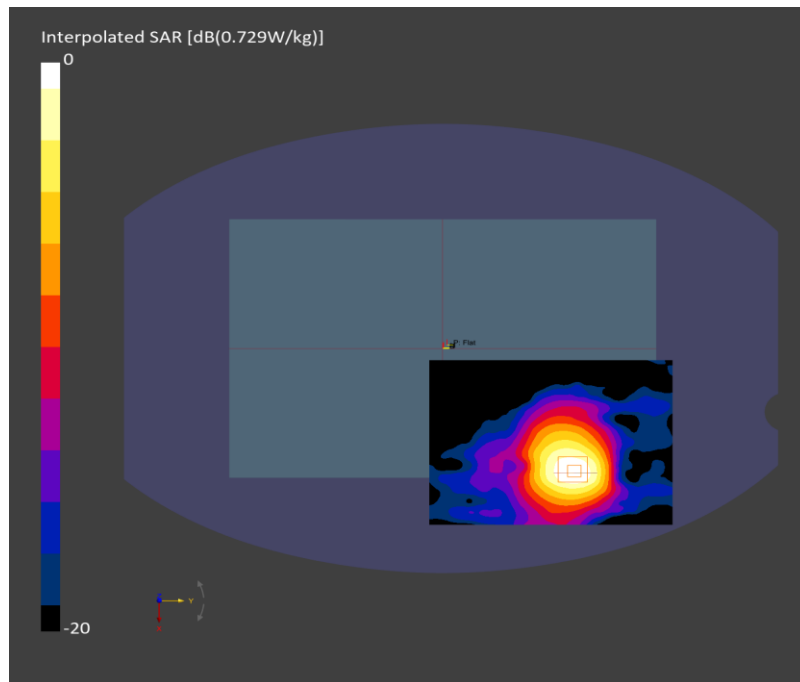


Figure C.29: Testing results for the A3375 at 5795.000 MHz



Measurement Report for A3375, BACK, U-NII 3, WiFi (802.11n): HT40 Mixed, MCS0 (13.5 Mbps), 99.7% DC, Channel 151 (5755.000 MHz)

Equipment Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	EUT Type
A3375,	316.0 x 220.0 x 15.0		Laptop

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 5.00	U-NII 3	WiFi (802.11n), 10117-	5755.000, 151	4.98	5.08	35.3

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2202	HBBL-600-10000 DAK 3.5 Head 19.08 deg.C 2026-Aug-27 SYS5 B9.prn, 2026-08-27	EX3DV4 - SN3759, 2025-12-04	DAE4ip Sn1785, 2026-02-09

Scans Setup

	Area Scan	Zoom Scan	Zoom Scan 2
Grid Extents [mm]	130.0 x 300.0	22.0 x 22.0 x 22.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4	1.4
Graded Grid	N/A	Yes	Yes
Grading Ratio	N/A	1.4	1.4
MAIA	N/A	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan	Zoom Scan 2
Date	2026-08-27, 15:05	2026-08-27, 15:15	2026-08-27, 15:23
psSAR1g [W/kg]	0.712	0.747	0.765
psSAR10g [W/kg]	0.289	0.299	0.302
Power Drift [dB]	0.03	-0.01	0.03
Power Scaling	Disabled	Disabled	Disabled
Scaling Factor [dB]			
TSL Correction	Positive only	Positive only	Positive only
M2/M1 [%]		57.3	57.7
Dist 3dB Peak [mm]		14.0	12.7

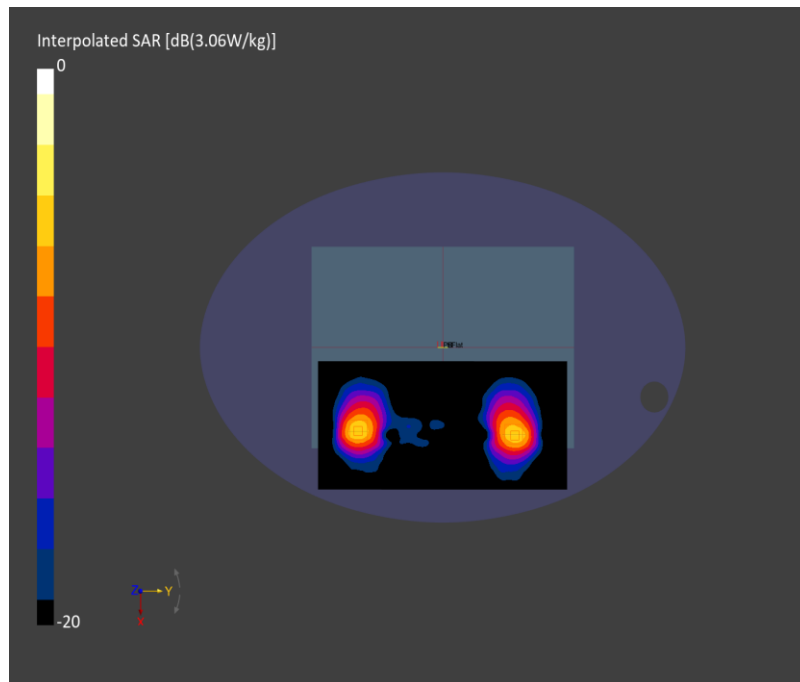


Figure C.30: Testing results for the A3375 at 5755.000 MHz



Measurement Report for A3375, BACK, U-NII 5, WiFi (802.11ax): HE160, MCS0 (72.0 Mbps), 98.0% DC, Channel 79 (6345.000 MHz)

Equipment Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	EUT Type
A3375,	312.0 x 218.0 x 16.0		Laptop

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 5.00	U-NII 5	WiFi (802.11ax), 10755-	6345.000, 79	5.29	5.81	35.0

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2102	HBBL-600-10000 DAK 3.5 Head 20.12 deg.C 2026-Aug-25 SYS3 B11.prn, 2026-08-25	EX3DV4 - SN7804, 2026-08-10	DAE4ip Sn1786, 2026-07-31

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	150.0 x 170.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	8.5 x 8.5	3.4 x 3.4 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-08-26, 12:19	2026-08-26, 12:29
psSAR1g [W/kg]	0.475	0.488
psSAR10g [W/kg]	0.183	0.188
psAPD (4.0cm2, sq) [W/m2]		4.16
Power Drift [dB]	-0.12	-0.07
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only
M2/M1 [%]		52.4
Dist 3dB Peak [mm]		13.1

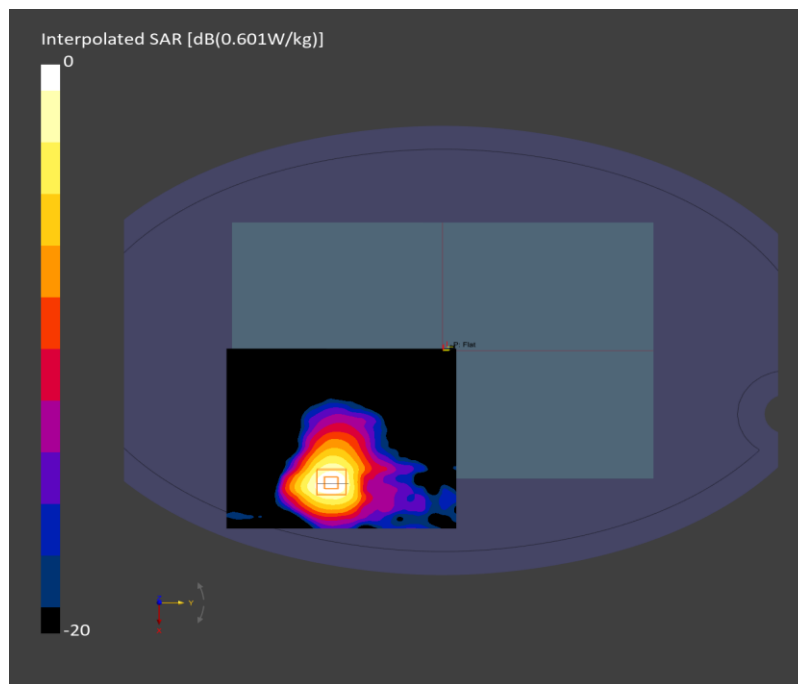


Figure C.31: Testing results for the A3375 at 6345.000 MHz



Measurement Report for A3375, BACK, U-NII 5, WiFi (802.11ax): HE160, MCS0 (72.0 Mbps), 98.0% DC, Channel 47 (6185.000 MHz)

Equipment Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	EUT Type
A3375,	316.0 x 220.0 x 15.0		Laptop

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 5.00	U-NII 5	WiFi (802.11ax), 10755-	6185.000, 47	5.29	5.61	35.3

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2102	HBBL-600-10000 DAK 3.5 Head 20.12 deg.C 2026-Aug-25 SYS3 B11.prn, 2026-08-25	EX3DV4 - SN7804, 2026-08-10	DAE4ip Sn1786, 2026-07-31

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	130.0 x 170.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	8.5 x 8.5	3.4 x 3.4 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-08-27, 05:00	2026-08-27, 05:10
psSAR1g [W/kg]	0.304	0.317
psSAR10g [W/kg]	0.122	0.125
psAPD (4.0cm2, sq) [W/m2]		2.78
Power Drift [dB]	-0.12	-0.24
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only
M2/M1 [%]		53.1
Dist 3dB Peak [mm]		14.1

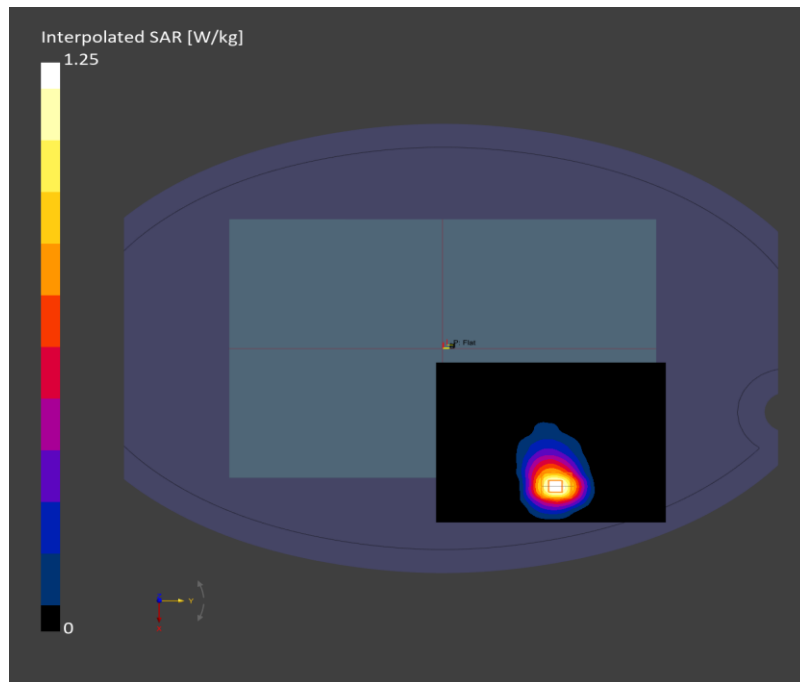


Figure C.32: Testing results for the A3375 at 6185.000 MHz



Measurement Report for A3375, BACK, U-NII 5, WiFi (802.11ax): HE160, MCS0 (72.0 Mbps), 98.0% DC, Channel 79 (6345.000 MHz)

Equipment Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	EUT Type
A3375,	316.0 x 220.0 x 15.0		Laptop

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 5.00	U-NII 5	WiFi (802.11ax), 10755-	6345.000, 79	5.26	5.59	33.6

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2203	HBBL-600-10000 DAK 3.5 Head 19.83 deg.C 2026-Aug-31 SYS6 B10.prn, 2026-08-31	EX3DV4 - SN7809, 2026-05-11	DAE4ip Sn1789, 2026-05-08

Scans Setup

-	Area Scan	Zoom Scan	Zoom Scan 2
Grid Extents [mm]	130.0 x 300.0	22.0 x 22.0 x 22.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	8.5 x 8.5	3.4 x 3.4 x 1.4	3.4 x 3.4 x 1.4
Sensor Surface [mm]	3.0	1.4	1.4
Graded Grid	N/A	Yes	Yes
Grading Ratio	N/A	1.4	1.4
MAIA	N/A	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured	Measured

Measurement Results

-	Area Scan	Zoom Scan	Zoom Scan 2
Date	2026-08-31, 12:13	2026-08-31, 12:26	2026-08-31, 12:36
psSAR1g [W/kg]	0.330	0.336	0.286
psSAR10g [W/kg]	0.132	0.136	0.114
psAPD (4.0cm2, sq) [W/m2]		3.00	2.50
Power Drift [dB]	0.10	-0.19	-0.02
Power Scaling	Disabled	Disabled	Disabled
Scaling Factor [dB]			
TSL Correction	Positive only	Positive only	Positive only
M2/M1 [%]		51.9	52.7
Dist 3dB Peak [mm]		12.5	13.6

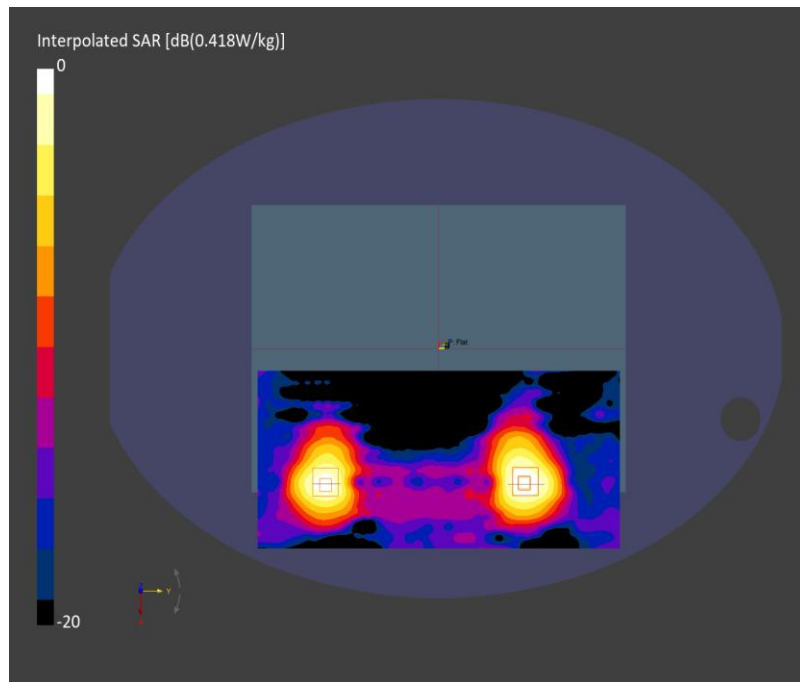


Figure C.33: Testing results for the A3375 at 6345.000 MHz



Measurement Report for A3375, BACK, U-NII 6, WiFi (802.11ax): HE160, MCS0 (72.0 Mbps), 98.0% DC, Channel 111 (6505.000 MHz)

Equipment Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	EUT Type
A3375,	312.0 x 218.0 x 16.0		Laptop

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 5.00	U-NII 6	WiFi (802.11ax), 10755-	6505.000, 111	5.29	6.00	34.7

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2102	HBBL-600-10000 DAK 3.5 Head 20.12 deg.C 2026-Aug-25 SYS3 B11.prn, 2026-08-25	EX3DV4 - SN7804, 2026-08-10	DAE4ip Sn1786, 2026-07-31

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	150.0 x 170.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	8.5 x 8.5	3.4 x 3.4 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	Y	Y
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-08-26, 13:57	2026-08-26, 14:12
psSAR1g [W/kg]	0.081	0.080
psSAR10g [W/kg]	0.030	0.031
psAPD (4.0cm2, sq) [W/m2]		0.676
Power Drift [dB]	-0.02	-0.70
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only
M2/M1 [%]		52.6
Dist 3dB Peak [mm]		9.0

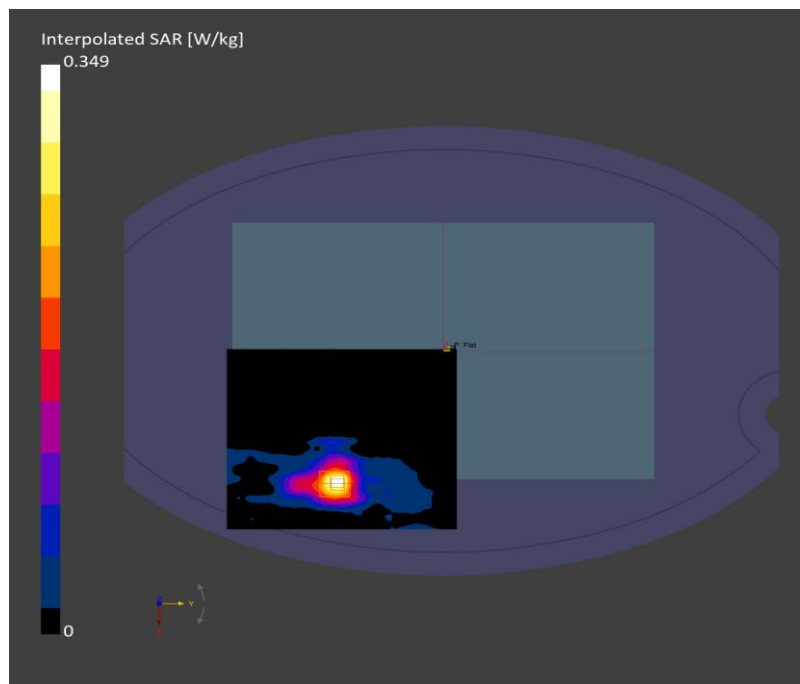


Figure C.34: Testing results for the A3375 at 6505.000 MHz



Measurement Report for A3375, BACK, U-NII 6, WiFi (802.11ax): HE160, MCS0 (72.0 Mbps), 98.0% DC, Channel 111 (6505.000 MHz)

Equipment Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	EUT Type
A3375,	316.0 x 220.0 x 15.0		Laptop

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 5.00	U-NII 6	WiFi (802.11ax), 10755-	6505.000, 111	5.29	6.00	34.7

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2102	HBBL-600-10000 DAK 3.5 Head 20.12 deg.C 2026-Aug-25 SYS3 B11.prn, 2026-08-25	EX3DV4 - SN7804, 2026-08-10	DAE4ip Sn1786, 2026-07-31

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	130.0 x 170.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	8.5 x 8.5	3.4 x 3.4 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	Y	Y
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-08-27, 05:45	2026-08-27, 05:56
psSAR1g [W/kg]	0.038	0.037
psSAR10g [W/kg]	0.014	0.014
Power Drift [dB]	0.27	0.45
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only
M2/M1 [%]		56.8
Dist 3dB Peak [mm]		10.2

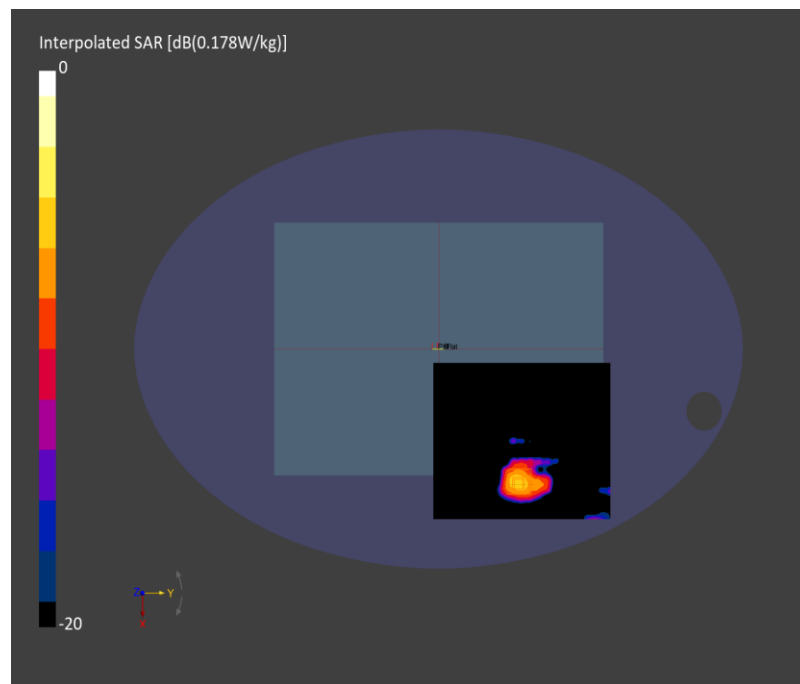


Figure C.35: Testing results for the A3375 at 6505.000 MHz



Measurement Report for A3375, BACK, U-NII 6, WiFi (802.11ax): ET160, MCS0 (72.0 Mbps), 98.0% DC, Channel 111 (6505.000 MHz)

Equipment Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	EUT Type
A3375,	316.0 x 220.0 x 15.0		Laptop

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 5.00	U-NII 6	WiFi (802.11ax), 10755-	6505.000, 111	5.32	5.82	33.5

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2270	DAK 3.5 Head 19.02 deg.C 2026-Sep-02 SYS4 B8 , 2026-09-02	EX3DV4 - SN7973, 2026-02-24	DAE4ip Sn1935, 2026-02-18

Scans Setup

-	Area Scan	Zoom Scan	Zoom Scan 2
Grid Extents [mm]	130.0 x 300.0	22.0 x 22.0 x 22.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	8.5 x 8.5	3.4 x 3.4 x 1.4	3.4 x 3.4 x 1.4
Sensor Surface [mm]	3.0	1.4	1.4
Graded Grid	N/A	Yes	Yes
Grading Ratio	N/A	1.4	1.4
MAIA	Y	Y	Y
Surface Detection	VMS + 6p	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured	Measured

Measurement Results

-	Area Scan	Zoom Scan	Zoom Scan 2
Date	2026-09-02, 11:46	2026-09-02, 12:00	2026-09-02, 12:12
psSAR1g [W/Kg]	0.019	0.024	0.024
psSAR10g [W/Kg]	0.007	0.009	0.008
psAPD (4.0cm2, sq) [W/m2]		0.203	0.189
Power Drift [dB]	-1.71	-1.21	1.05
Power Scaling	Disabled	Disabled	Disabled
Scaling Factor [dB]			
TSL Correction	Positive only	Positive only	Positive only
M2/M1 [%]		50.7	51.2
Dist 3dB Peak [mm]		9.6	8.9

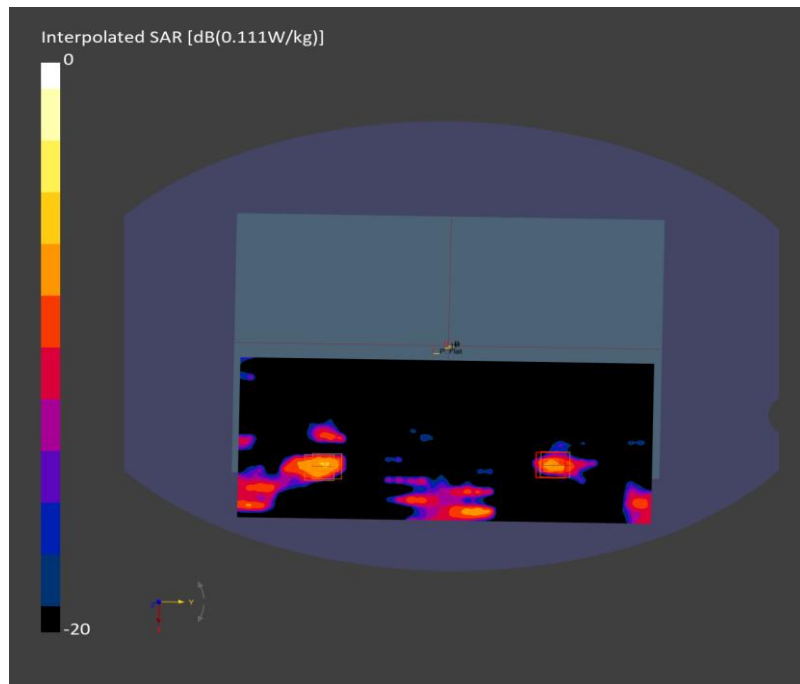


Figure C.36: Testing results for the A3375 at 6505.000 MHz



Measurement Report for A3375, BACK, U-NII 7, WiFi (802.11ax): HE160, MCS0 (72.0 Mbps), 98.0% DC, Channel 143 (6665.000 MHz)

Equipment Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	EUT Type
A3375,	316.0 x 220.0 x 15.0		Laptop

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 5.00	U-NII 7	WiFi (802.11ax), 10755-	6665.000, 143	5.29	6.20	34.5

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2102	HBBL-600-10000 DAK 3.5 Head 20.12 deg.C 2026-Aug-25 SYS3 B11.prn, 2026-08-25	EX3DV4 - SN7804, 2026-08-10	DAE4ip Sn1786, 2026-07-31

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	130.0 x 170.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	8.5 x 8.5	3.4 x 3.4 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-08-26, 18:22	2026-08-26, 18:37
psSAR1g [W/kg]	0.278	0.280
psSAR10g [W/kg]	0.108	0.108
psAPD (4.0cm2, sq) [W/m2]		2.40
Power Drift [dB]	-0.30	-0.10
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only
M2/M1 [%]		51.4
Dist 3dB Peak [mm]		10.9

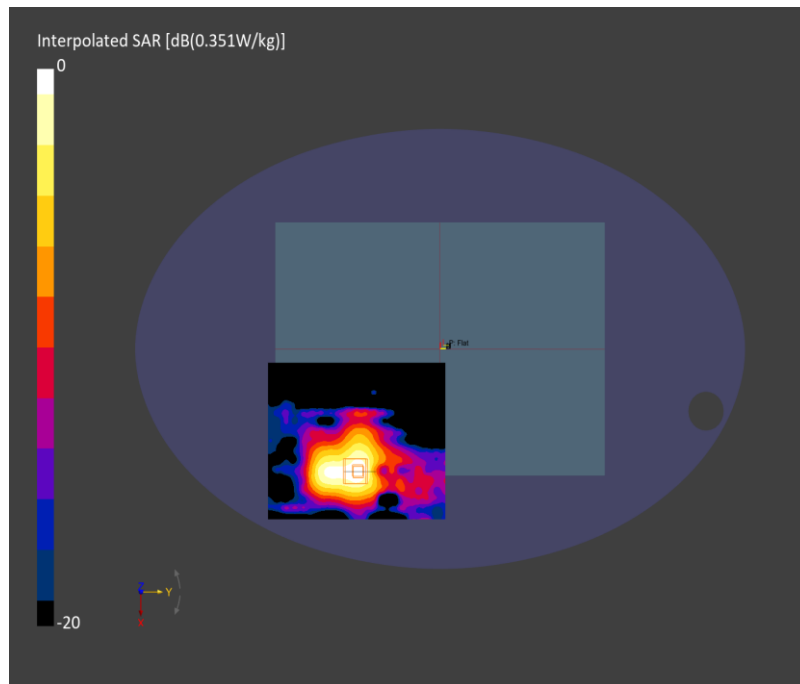


Figure C.37: Testing results for the A3375 at 6665.000 MHz



Measurement Report for A3375, BACK, U-NII 7, WiFi (802.11ax): HE160, MCS0 (72.0 Mbps), 98.0% DC, Channel 143 (6665.000 MHz)

Equipment Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	EUT Type
A3375,	316.0 x 220.0 x 15.0		Laptop

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 5.00	U-NII 7	WiFi (802.11ax), 10755-	6665.000, 143	5.29	5.91	32.8

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2202	HBBL-600-10000 DAK 3.5 Head 19.52 deg.C 2026-Aug-31 SYS5 B9.prn, 2026-08-31	EX3DV4 - SN3759, 2025-12-04	DAE4ip Sn1785, 2026-02-09

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	130.0 x 170.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	8.5 x 8.5	3.4 x 3.4 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-08-31, 11:18	2026-08-31, 11:29
psSAR1g [W/kg]	0.282	0.282
psSAR10g [W/kg]	0.109	0.108
psAPD (4.0cm2, sq) [W/m2]		2.38
Power Drift [dB]	-0.00	0.07
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only
M2/M1 [%]		49.8
Dist 3dB Peak [mm]		9.8

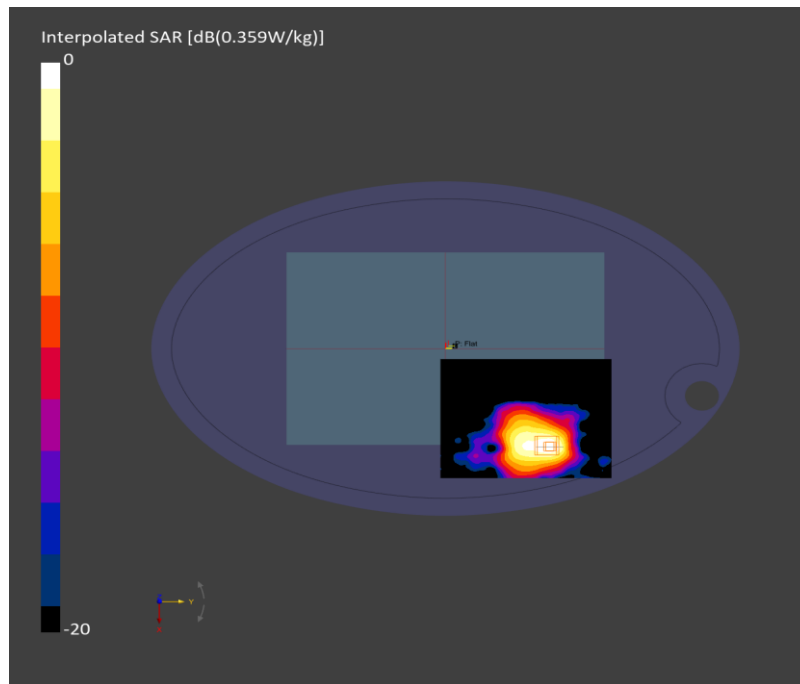


Figure C.38: Testing results for the A3375 at 6665.000 MHz



Measurement Report for A3375, BACK, U-NII 7, WiFi (802.11ax): ET160, MCS0 (72.0 Mbps), 98.0% DC, Channel 143 (6665.000 MHz)

Equipment Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	EUT Type
A3375,	316.0 x 220.0 x 15.0		Laptop

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 5.00	U-NII 7	WiFi (802.11ax), 10755-	6665.000, 143	5.32	5.95	33.3

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2270	DAK 3.5 Head 19.8 deg.C 2026-Aug-31 SYS4 B8 , 2026-08-31	EX3DV4 - SN7973, 2026-02-24	DAE4ip Sn1935, 2026-02-18

Scans Setup

-	Area Scan	Zoom Scan	Zoom Scan 2
Grid Extents [mm]	130.0 x 300.0	22.0 x 22.0 x 22.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	8.5 x 8.5	3.4 x 3.4 x 1.4	3.4 x 3.4 x 1.4
Sensor Surface [mm]	3.0	1.4	1.4
Graded Grid	N/A	Yes	Yes
Grading Ratio	N/A	1.4	1.4
MAIA	N/A	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured	Measured

Measurement Results

-	Area Scan	Zoom Scan	Zoom Scan 2
Date	2026-09-01, 11:37	2026-09-01, 11:51	2026-09-01, 12:02
psSAR1g [W/Kg]	0.329	0.314	0.213
psSAR10g [W/Kg]	0.133	0.126	0.082
psAPD (4.0cm2, sq) [W/m2]		2.77	1.81
Power Drift [dB]	-0.06	-0.20	-0.20
Power Scaling	Disabled	Disabled	Disabled
Scaling Factor [dB]			
TSL Correction	Positive only	Positive only	Positive only
M2/M1 [%]		50.4	52.5
Dist 3dB Peak [mm]		10.2	10.8

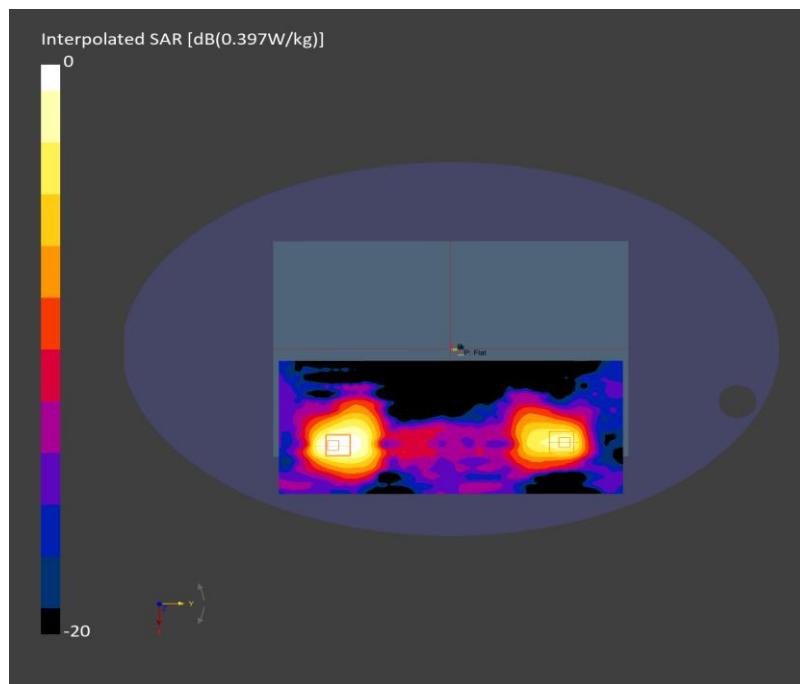


Figure C.39: Testing results for the A3375 at 6665.000 MHz



Measurement Report for A3375, BACK, U-NII 8, WiFi (802.11ax): HE160, MCS0 (72.0 Mbps), 98.0% DC, Channel 207 (6985.000 MHz)

Equipment Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	EUT Type
A3375,	316.0 x 220.0 x 15.0		Laptop

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 5.00	U-NII 8	WiFi (802.11ax), 10755-	6985.000, 207	5.29	6.59	33.9

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2102	HBBL-600-10000 DAK 3.5 Head 20.12 deg.C 2026-Aug-25 SYS3 B11.prn, 2026-08-25	EX3DV4 - SN7804, 2026-08-10	DAE4ip Sn1786, 2026-07-31

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	130.0 x 170.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	8.5 x 8.5	3.4 x 3.4 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	Y	Y
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-08-26, 21:49	2026-08-26, 22:04
psSAR1g [W/kg]	0.079	0.081
psSAR10g [W/kg]	0.029	0.028
psAPD (4.0cm2, sq) [W/m2]		0.619
Power Drift [dB]	-2.64	-0.83
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only
M2/M1 [%]		49.8
Dist 3dB Peak [mm]		9.1

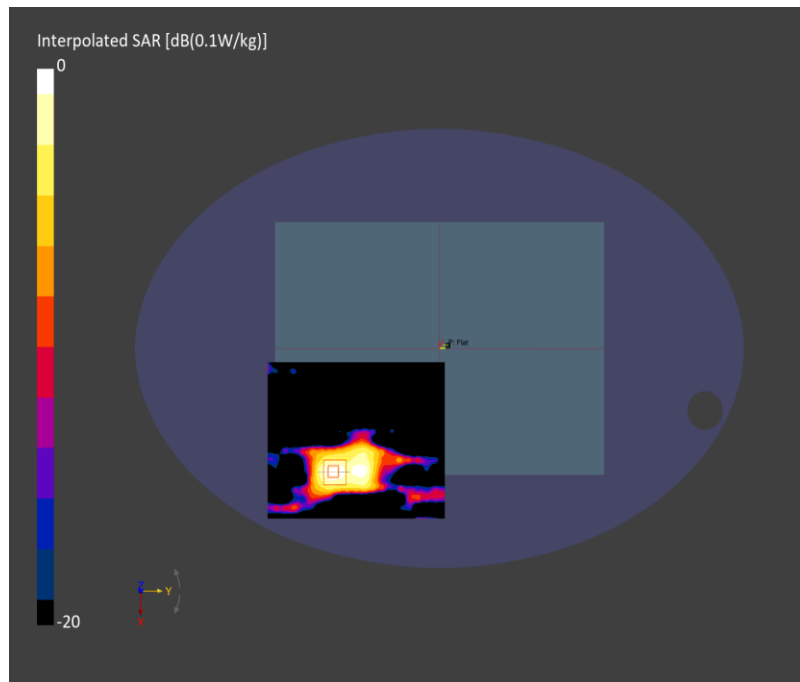


Figure C.40: Testing results for the A3375 at 6985.000 MHz



Measurement Report for A3375, BACK, U-NII 8, WiFi (802.11ax): ET160, MCS0 (72.0 Mbps), 98.0% DC, Channel 207 (6985.000 MHz)

Equipment Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	EUT Type
A3375,	316.0 x 220.0 x 15.0		Laptop

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 5.00	U-NII 8	WiFi (802.11ax), 10755-	6985.000, 207	5.32	6.32	32.8

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2270	DAK 3.5 Head 19.8 deg.C 2026-Aug-31 SYS4 B8 , 2026-08-31	EX3DV4 - SN7973, 2026-02-24	DAE4ip Sn1935, 2026-02-18

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	130.0 x 170.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	8.5 x 8.5	3.4 x 3.4 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	Y	Y
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-09-01, 09:55	2026-09-01, 10:08
psSAR1g [W/Kg]	0.104	0.107
psSAR10g [W/Kg]	0.038	0.039
psAPD (4.0cm2, sq) [W/m2]		0.877
Power Drift [dB]	-0.28	0.18
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only
M2/M1 [%]		48.6
Dist 3dB Peak [mm]		11.4

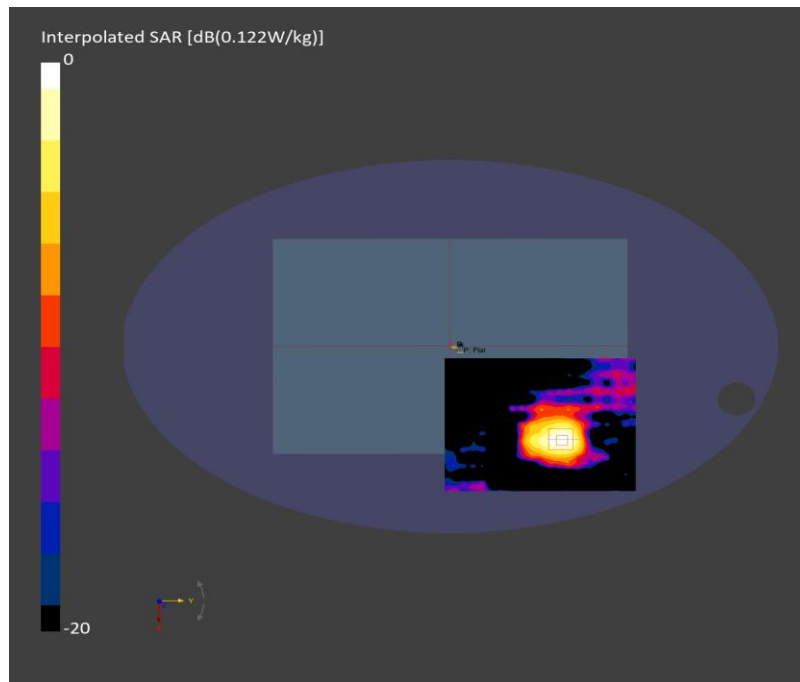


Figure C.41: Testing results for the A3375 at 6985.000 MHz



Measurement Report for A3375, BACK, U-NII 8, WiFi (802.11ax): ET160, MCS0 (72.0 Mbps), 98.0% DC, Channel 207 (6985.000 MHz)

Equipment Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	EUT Type
A3375,	316.0 x 220.0 x 15.0		Laptop

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	BACK, 5.00	U-NII 8	WiFi (802.11ax), 10755-	6985.000, 207	5.32	6.32	32.8

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2270	DAK 3.5 Head 19.8 deg.C 2026-Aug-31 SYS4 B8 , 2026-08-31	EX3DV4 - SN7973, 2026-02-24	DAE4ip Sn1935, 2026-02-18

Scans Setup

-	Area Scan	Zoom Scan	Zoom Scan 2
Grid Extents [mm]	130.0 x 300.0	22.0 x 22.0 x 22.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	8.5 x 8.5	3.4 x 3.4 x 1.4	3.4 x 3.4 x 1.4
Sensor Surface [mm]	3.0	1.4	1.4
Graded Grid	N/A	Yes	Yes
Grading Ratio	N/A	1.4	1.4
MAIA	Y	Y	Y
Surface Detection	VMS + 6p	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured	Measured

Measurement Results

-	Area Scan	Zoom Scan	Zoom Scan 2
Date	2026-09-02, 03:55	2026-09-02, 04:09	2026-09-02, 04:20
psSAR1g [W/kg]	0.068	0.066	0.048
psSAR10g [W/kg]	0.025	0.023	0.017
psAPD (4.0cm2, sq) [W/m2]		0.523	0.384
Power Drift [dB]	0.25	-0.69	-0.66
Power Scaling	Disabled	Disabled	Disabled
Scaling Factor [dB]			
TSL Correction	Positive only	Positive only	Positive only
M2/M1 [%]		48.2	50.3
Dist 3dB Peak [mm]		9.6	9.6

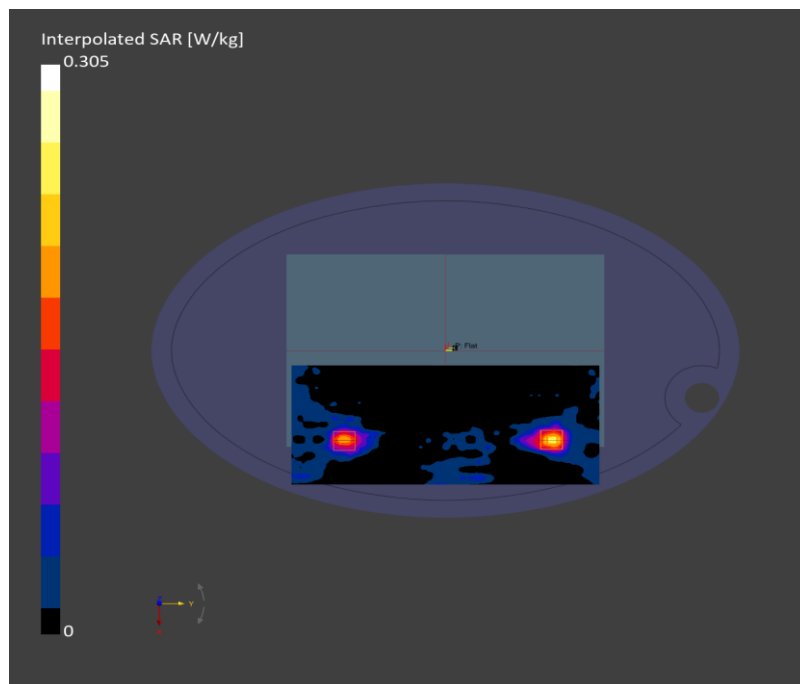


Figure C.42: Testing results for the A3375 at 6985.000 MHz



Measurement Report for Device, BACK, U-NII-5, IEEE 802.11ax (160MHz, MCS0, 99pc duty cycle), Channel 15 (6025.0 MHz)

Device Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	316.0 x 220.0 x 15.0		Laptop

Exposure Conditions

Phantom Section	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor
5G	BACK, 5.00	U-NII-5	WLAN, 10755-AAC	6025.0, 15	1.0

Hardware Setup

Phantom	Medium	Probe, Calibration Date	DAE, Calibration Date
mmWave - 1112	Air -	EUmmWV4 - SN9609_F1-55GHz, 2026-09-09	DAE4 Sn475, 2025-11-26

Scans Setup

Scan Type	5G Scan
Grid Extents [mm]	25.0 x 25.0
Grid Steps [lambda]	0.10255828175490554 x 0.10255828175490554
Sensor Surface [mm]	5.0
MAIA	Y

Measurement Results

Scan Type	5G Scan
Date	2026-09-17, 04:53
Avg. Area [cm ²]	4.00
psPDn+ [W/m ²]	5.20
psPDtot+ [W/m ²]	5.88
psPDmod+ [W/m ²]	6.36
E _{max} [V/m]	61.2
Power Drift [dB]	0.08

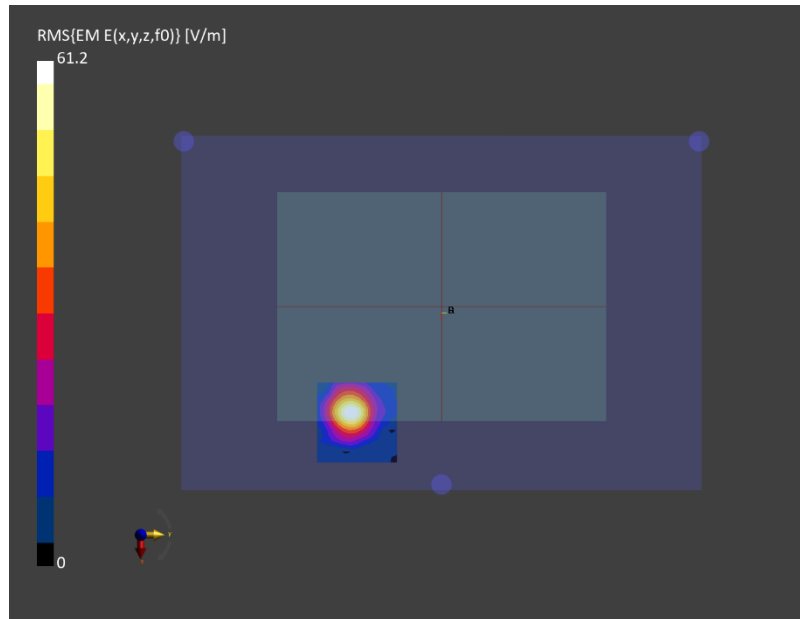


Figure C.43: iPD Testing results for the A3375 at 6025.000 MHz



ANNEX D

System Performance Check Results



System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]	Dev. 1g [%]	Dev. 10g [%]	Dev. Peak [%]	Iso. Error [%]
D2450V2 - SN715	2450.0	HSL	17.0	1.2	2.5	-4.2	0.8646111999935924

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	10		CW, 0-	2450.000, 0	6.9	1.68	39.6

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2202	HBBL-600-10000 DAK 3.5 Head 18.38 deg.C 2026-Aug-21 SYS5 B9.prn, 2026-08-21	EX3DV4 - SN3759, 2025-12-04	DAE4ip Sn1785, 2026-02-09

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 80.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-08-22, 17:03	2026-08-22, 17:10
psSAR1g [W/kg]	2.72	2.65
psSAR10g [W/kg]	1.25	1.25
Power Drift [dB]	-0.02	-0.06
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only

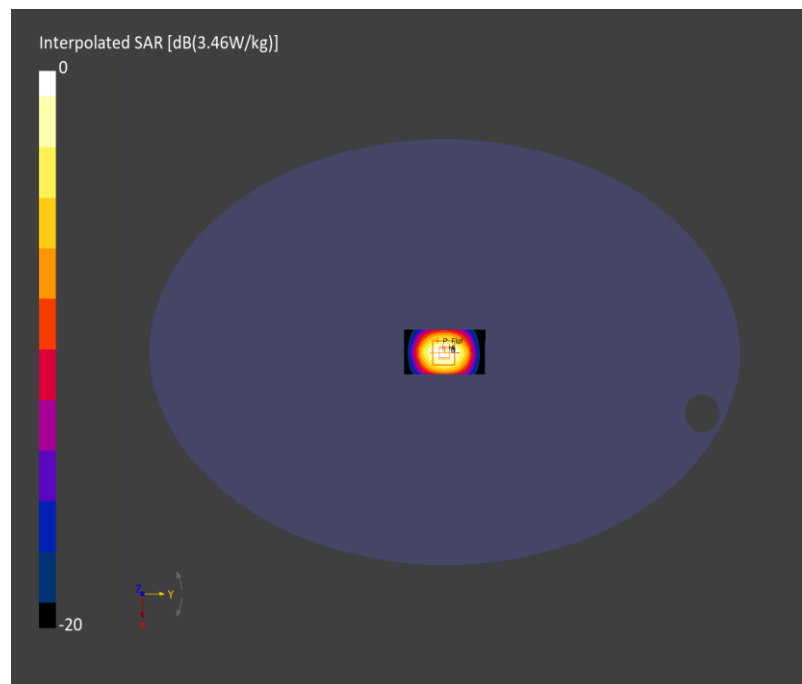


Figure D.1: SAR System performance check for 2450.000 MHz



System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]	Dev. 1g [%]	Dev. 10g [%]	Dev. Peak [%]	Iso. Error [%]
D2450V2 - SN715	2450.0	HSL	17.0	-6.7	-6.1	-8.6	0.5854369766111978

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	10		CW, 0-	2450.000, 0	7.63	1.69	39.9

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2203	HBBL-600-10000 DAK 3.5 Head 19.3 deg.C 2026-Aug-21 SYS6 B10.prn, 2026-08-21	EX3DV4 - SN7809, 2026-05-11	DAE4ip Sn1789, 2026-05-08

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 80.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-08-22, 17:36	2026-08-22, 17:43
psSAR1g [W/kg]	2.49	2.44
psSAR10g [W/kg]	1.14	1.15
Power Drift [dB]	-0.00	-0.01
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only

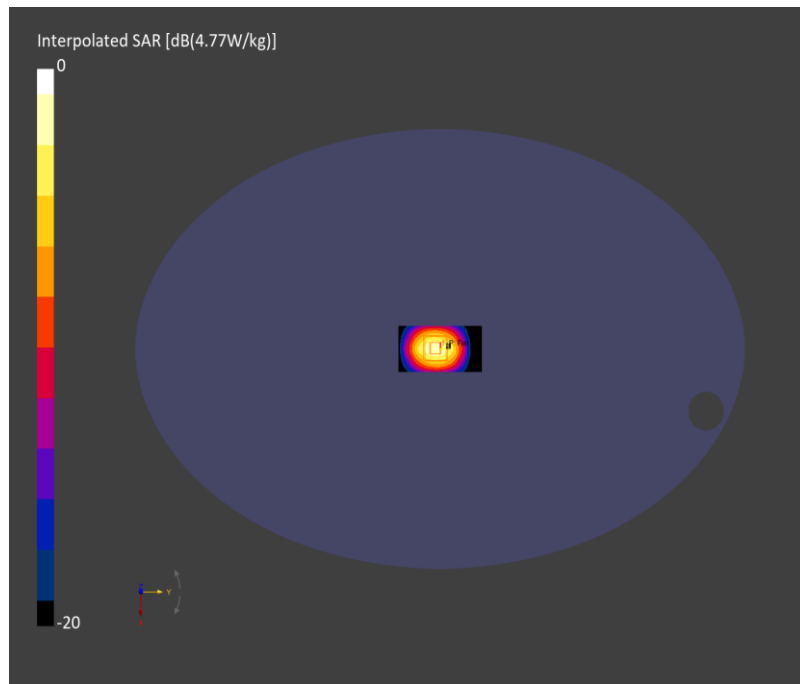


Figure D.2: SAR System performance check for 2450.000 MHz



System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]	Dev. 1g [%]	Dev. 10g [%]	Dev. Peak [%]	Iso. Error [%]
D2450V2 - SN715	2450.0	HSL	17.0	3.2	2.5	3.3	0.4722950335839471

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	10		CW, 0-	2450.000, 0	7.54	1.68	39.1

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2102	HBBL-600-10000 DAK 3.5 Head 20.67 deg.C 2026-Aug-23 SYS3 B11.prm, 2026-08-23	EX3DV4 - SN7804, 2026-08-10	DAE4ip Sn1786, 2026-07-31

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 80.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-08-23, 09:40	2026-08-23, 09:47
psSAR1g [W/kg]	2.60	2.70
psSAR10g [W/kg]	1.22	1.25
Power Drift [dB]	0.00	-0.01
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only

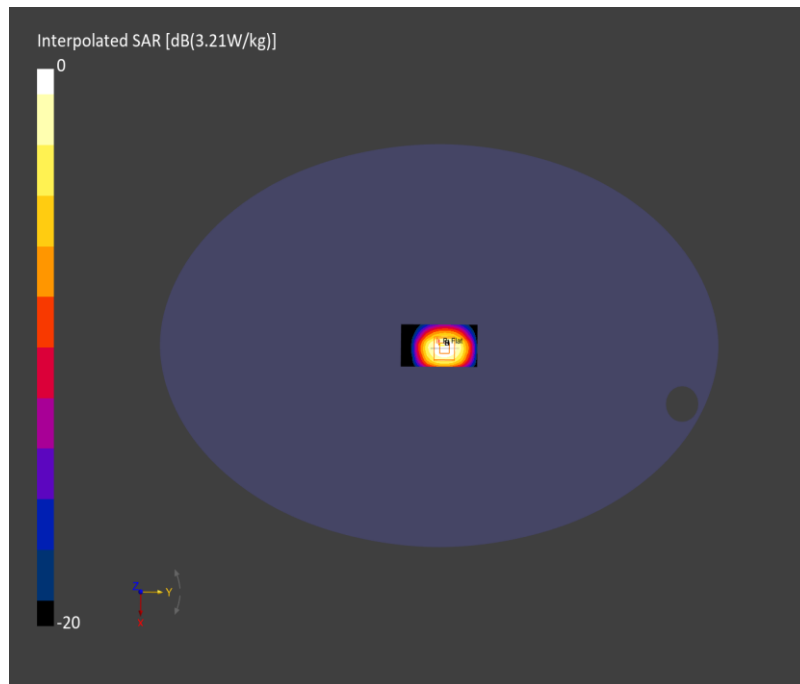


Figure D.3: SAR System performance check for 2450.000 MHz



System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]	Dev. 1g [%]	Dev. 10g [%]	Dev. Peak [%]	Iso. Error [%]
D2450V2 - SN715	2450.0	HSL	17.0	-7.3	-7.0	-11.3	0.7508361047024126

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	10		CW, 0-	2450.000, 0	7.63	1.66	39.0

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2203	HBBL-600-10000 DAK 3.5 Head 19.75 deg.C 2026-Aug-23 SYS6 B10.prm, 2026-08-23	EX3DV4 - SN7809, 2026-05-11	DAE4ip Sn1789, 2026-05-08

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 80.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-08-24, 08:52	2026-08-24, 08:59
psSAR1g [W/kg]	2.44	2.42
psSAR10g [W/kg]	1.12	1.14
Power Drift [dB]	0.01	0.00
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only

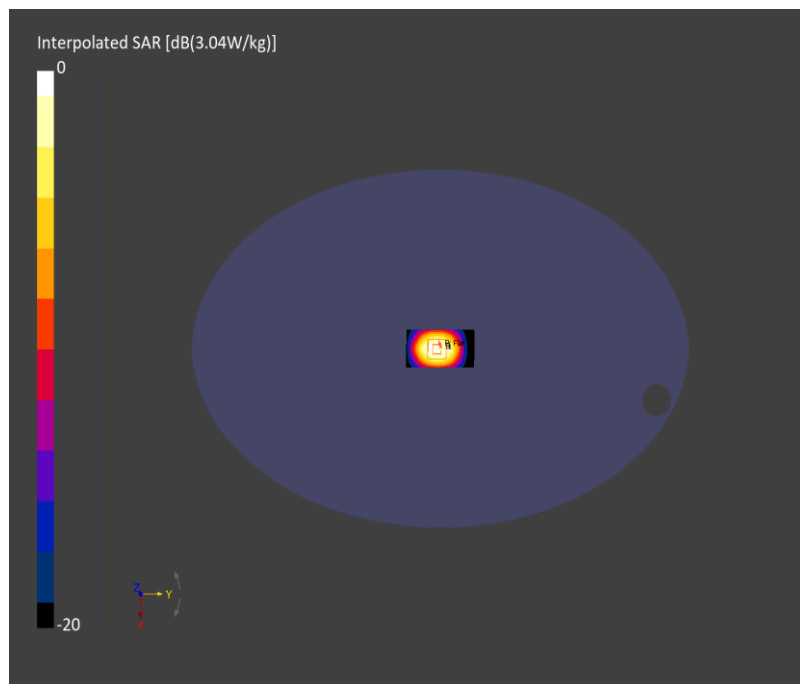


Figure D.4: SAR System performance check for 2450.000 MHz



System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]	Dev. 1g [%]	Dev. 10g [%]	Dev. Peak [%]	Iso. Error [%]
D5GHzV2 - SN1100	5200.0	HSL	17.0	-8.4	-7.4	-6.4	-2.2803282808472103

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	10		CW, 0-	5200.000, 0	5.57	4.42	37.3

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2202	HBBL-600-10000 DAK 3.5 Head 20.00 deg.C 2026-Aug-25 SYS5 B9.prn, 2026-08-25	EX3DV4 - SN3759, 2025-12-04	DAE4ip Sn1785, 2026-02-09

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 80.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-08-25, 09:06	2026-08-25, 09:17
psSAR1g [W/kg]	3.30	3.57
psSAR10g [W/kg]	0.946	1.03
Power Drift [dB]	-0.07	-0.05
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only

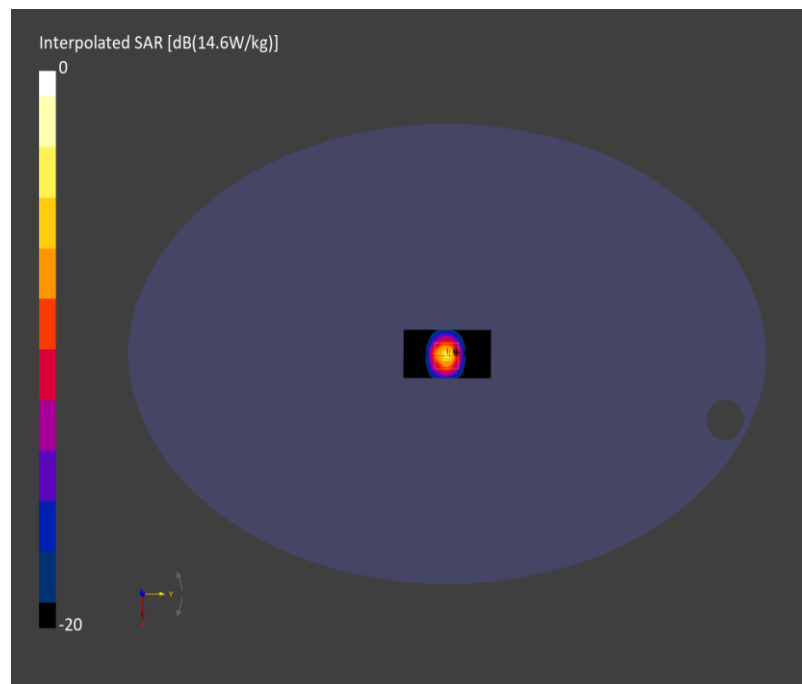


Figure D.5: SAR System performance check for 5200.000 MHz



System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]	Dev. 1g [%]	Dev. 10g [%]	Dev. Peak [%]	Iso. Error [%]
D5GHzV2 - SN1100	5300.0	HSL	17.0	-6.2	-6.0	-0.4	2.0308104987495357

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	10		CW, 0-	5300.000, 0	5.37	4.53	37.1

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2202	HBBL-600-10000 DAK 3.5 Head 20.00 deg.C 2026-Aug-25 SYS5 B9.prn, 2026-08-25	EX3DV4 - SN3759, 2025-12-04	DAE4ip Sn1785, 2026-02-09

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 80.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-08-25, 09:21	2026-08-25, 09:32
psSAR1g [W/kg]	3.46	3.76
psSAR10g [W/kg]	0.977	1.07
Power Drift [dB]	-0.07	-0.08
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only

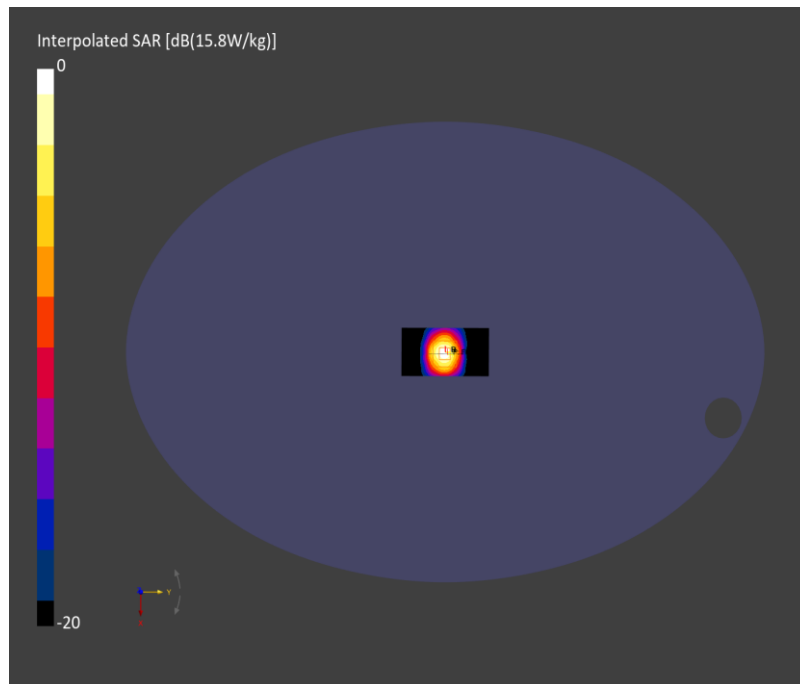


Figure D.6: SAR System performance check for 5300.000 MHz



System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]	Dev. 1g [%]	Dev. 10g [%]	Dev. Peak [%]	Iso. Error [%]
D5GHzV2 - SN1100	5600.0	HSL	17.0	2.2	6.6	9.3	0.8130648709395505

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	10		CW, 0-	5600.000, 0	4.95	4.92	36.9

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2203	HBBL-600-10000 DAK 3.5 Head 20.18 deg.C 2026-Aug-25 SYS6 B10.prm, 2026-08-25	EX3DV4 - SN7809, 2026-05-11	DAE4ip Sn1789, 2026-05-08

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 80.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-08-25, 11:42	2026-08-25, 11:52
psSAR1g [W/kg]	3.51	4.18
psSAR10g [W/kg]	1.14	1.23
Power Drift [dB]	-0.00	0.00
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only

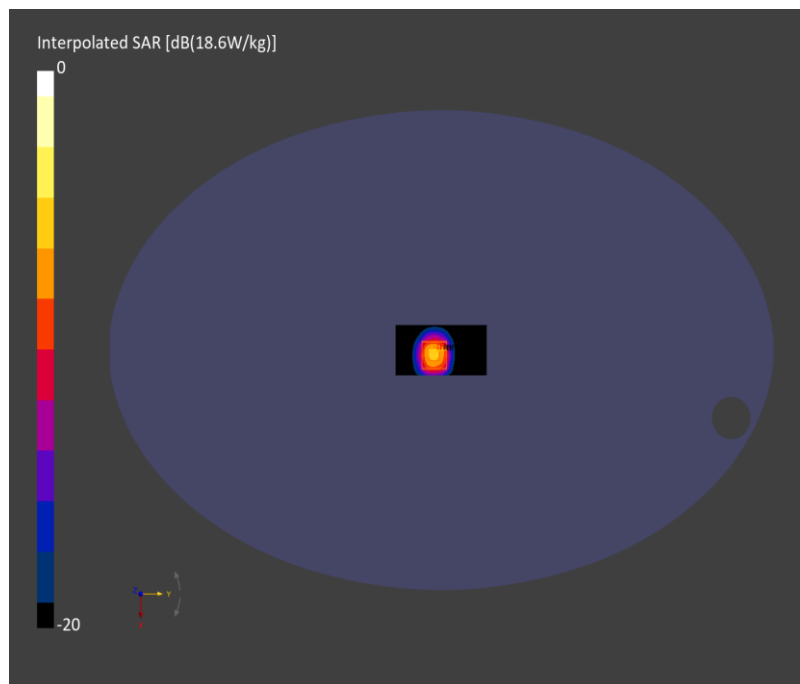


Figure D.7: SAR System performance check for 5600.000 MHz



System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]	Dev. 1g [%]	Dev. 10g [%]	Dev. Peak [%]	Iso. Error [%]
D5GHzV2 - SN1100	5800.0	HSL	17.0	2.0	4.0	12.4	0.8410757612936637

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	10		CW, 0-	5800.000, 0	5.06	5.17	36.5

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2203	HBBL-600-10000 DAK 3.5 Head 20.18 deg.C 2026-Aug-25 SYS6 B10.prm, 2026-08-25	EX3DV4 - SN7809, 2026-05-11	DAE4ip Sn1789, 2026-05-08

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 80.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-08-25, 11:11	2026-08-25, 11:21
psSAR1g [W/kg]	3.76	4.15
psSAR10g [W/kg]	1.12	1.19
Power Drift [dB]	-0.05	0.13
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only

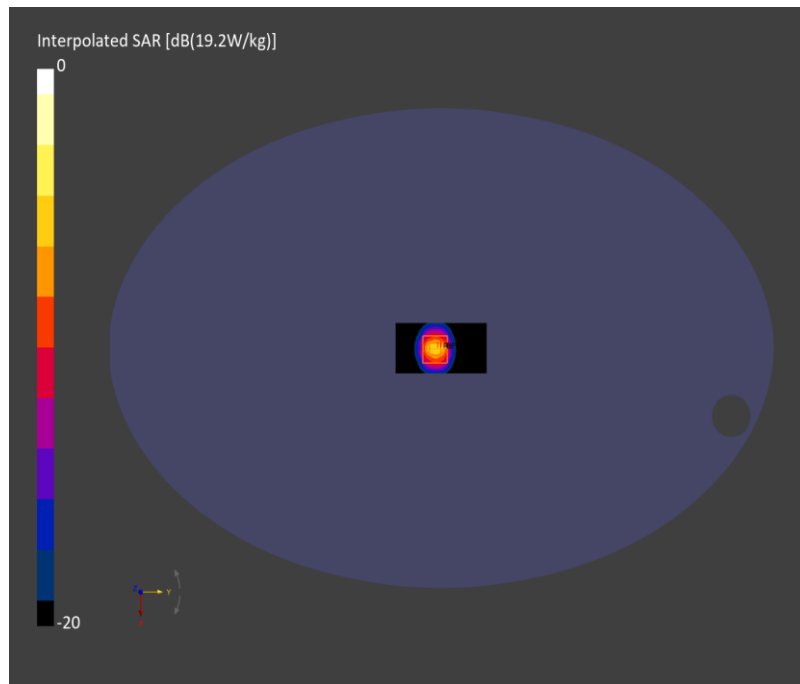


Figure D.8: SAR System performance check for 5800.000 MHz



System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]	Dev. 1g [%]	Dev. 10g [%]	Dev. Peak [%]	Iso. Error [%]
D5GHzV2 - SN1100	5200.0	HSL	17.0	2.7	4.5	2.8	1.7547963432245073

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	10		CW, 0-	5200.000, 0	5.42	4.46	36.9

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2270	DAK 3.5 Head 18.99 deg.C 2026-Aug-25 SYS4 B8 DAK 3.5 Head 18.99 deg.C 2026-Aug-25 SYS4 B8.prn, 2026-08-25	EX3DV4 - SN7973, 2026-02-24	DAE4ip Sn1935, 2026-02-18

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 80.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-08-26, 08:24	2026-08-26, 08:35
psSAR1g [W/Kg]	3.59	4.00
psSAR10g [W/Kg]	1.13	1.16
Power Drift [dB]	-0.02	-0.04
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only

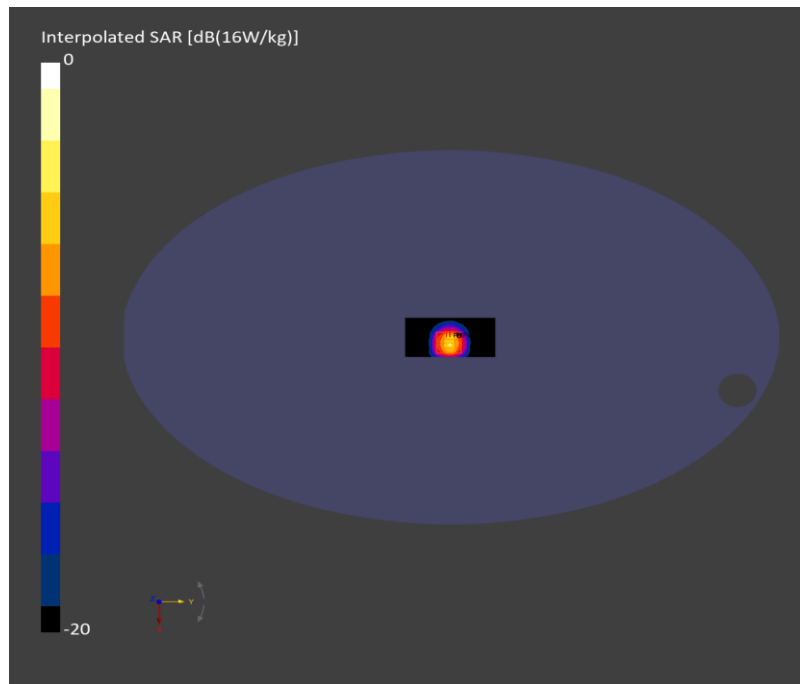


Figure D.9: SAR System performance check for 5200.000 MHz



System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]	Dev. 1g [%]	Dev. 10g [%]	Dev. Peak [%]	Iso. Error [%]
D5GHzV2 - SN1100	5300.0	HSL	17.0	-0.2	2.0	3.9	-2.11545459880802

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	10		CW, 0-	5300.000, 0	5.28	4.58	36.7

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2270	DAK 3.5 Head 18.99 deg.C 2026-Aug-25 SYS4 B8 DAK 3.5 Head 18.99 deg.C 2026-Aug-25 SYS4 B8.pn, 2026-08-25	EX3DV4 - SN7973, 2026-02-24	DAE4ip Sn1935, 2026-02-18

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 80.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-08-26, 08:38	2026-08-26, 08:46
psSAR1g [W/Kg]	3.59	4.01
psSAR10g [W/Kg]	1.12	1.16
Power Drift [dB]	0.00	-0.04
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only

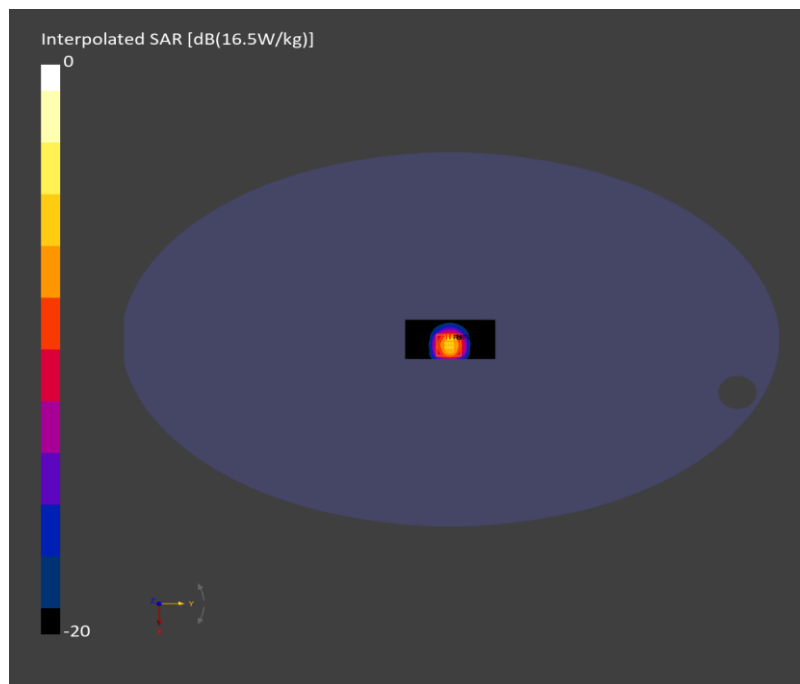


Figure D.10: SAR System performance check for 5300.000 MHz



System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]	Dev. 1g [%]	Dev. 10g [%]	Dev. Peak [%]	Iso. Error [%]
D5GHzV2 - SN1291	5600.0	HSL	17.0	5.8	6.6	12.6	-1.9606476522062155

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	10		CW, 0-	5600.000, 0	4.86	4.93	36.2

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2270	DAK 3.5 Head 18.99 deg.C 2026-Aug-25 SYS4 B8 DAK 3.5 Head 18.99 deg.C 2026-Aug-25 SYS4 B8.prn, 2026-08-25	EX3DV4 - SN7973, 2026-02-24	DAE4ip Sn1935, 2026-02-18

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 80.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-08-26, 09:13	2026-08-26, 09:20
psSAR1g [W/Kg]	3.84	4.24
psSAR10g [W/Kg]	1.16	1.23
Power Drift [dB]	0.02	0.02
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only

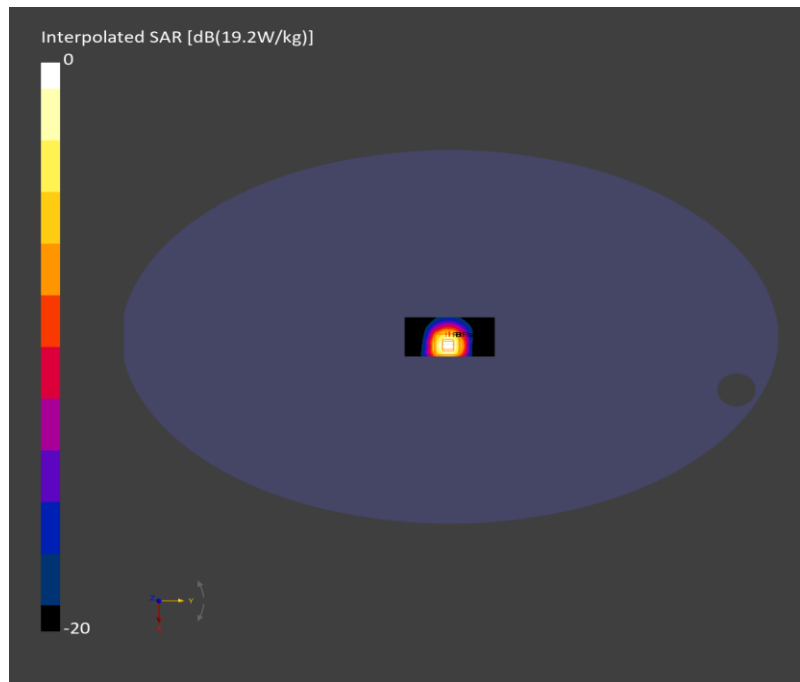


Figure D.11: SAR System performance check for 5600.000 MHz



System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]	Dev. 1g [%]	Dev. 10g [%]	Dev. Peak [%]	Iso. Error [%]
D5GHzV2 - SN1100	5800.0	HSL	17.0	2.5	6.3	15.8	-2.1701903518656973

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	10		CW, 0-	5800.000, 0	4.88	5.16	35.8

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2270	DAK 3.5 Head 18.99 deg.C 2026-Aug-25 SYS4 B8 DAK 3.5 Head 18.99 deg.C 2026-Aug-25 SYS4 B8.prn, 2026-08-25	EX3DV4 - SN7973, 2026-02-24	DAE4ip Sn1935, 2026-02-18

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 80.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-08-26, 10:04	2026-08-26, 10:15
psSAR1g [W/Kg]	3.53	4.17
psSAR10g [W/Kg]	1.11	1.21
Power Drift [dB]	-0.03	-0.01
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only

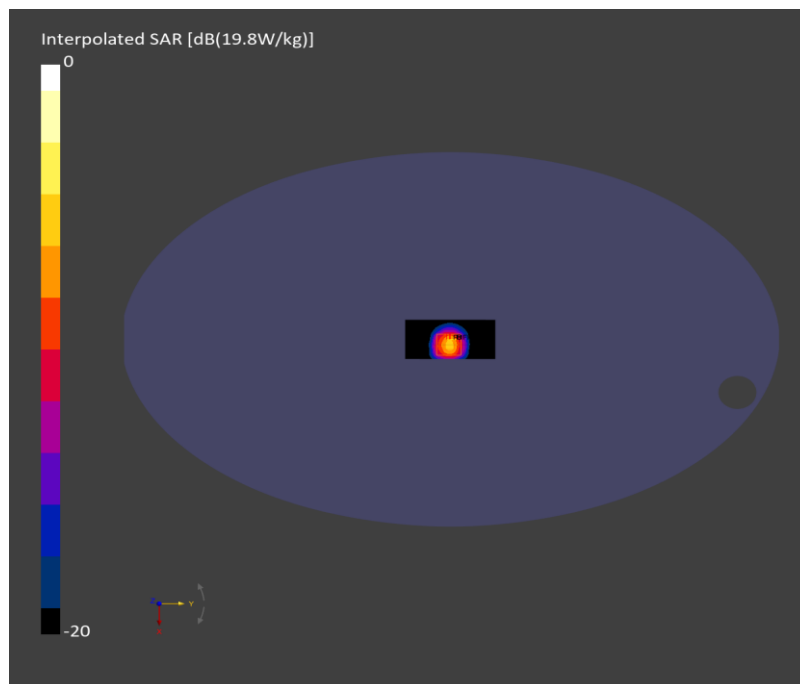


Figure D.12: SAR System performance check for 5800.000 MHz



System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]	Dev. 1g [%]	Dev. 10g [%]	Dev. Peak [%]	Iso. Error [%]
D6.5GHzV2 - SN1071	6500.0	HSL	20.0	-3.6	-1.5	-9.3	1.760006770966549

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	5		CW, 0-	6500.000, 0	5.29	6.00	34.7

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2102	HBBL-600-10000 DAK 3.5 Head 20.12 deg.C 2026-Aug-25 SYS3 B11.prn, 2026-08-25	EX3DV4 - SN7804, 2026-08-10	DAE4ip Sn1786, 2026-07-31

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	51.0 x 85.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	8.5 x 8.5	3.4 x 3.4 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-08-26, 01:32	2026-08-26, 01:44
psSAR1g [W/kg]	21.9	29.3
psSAR10g [W/kg]	5.06	5.57
psAPD (4.0cm2, sq) [W/m2]		135
Power Drift [dB]	-0.05	0.02
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only

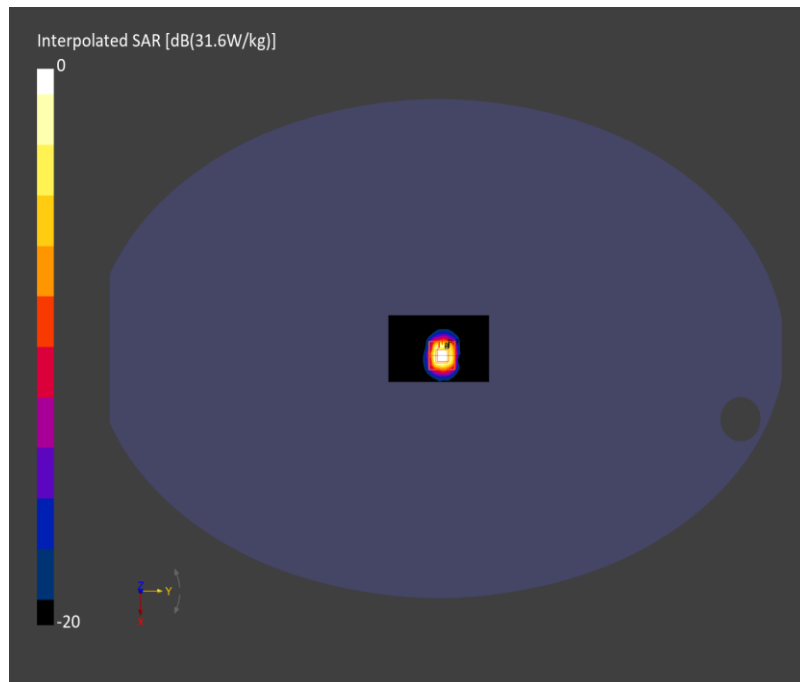


Figure D.13: SAR & APD System performance check for 6500.000 MHz



System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]	Dev. 1g [%]	Dev. 10g [%]	Dev. Peak [%]	Iso. Error [%]
D5GHzV2 - SN1100	5200.0	HSL	17.0	6.5	8.8	6.9	1.1984149590403614

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	10		CW, 0-	5200.000, 0	5.42	4.57	37.0

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2270	DAK 3.5 Head 18.29 deg.C 2026-Aug-27 SYS4 B8 DAK 3.5 Head 18.29 deg.C 2026-Aug-27 SYS4 B8.pn, 2026-08-27	EX3DV4 - SN7973, 2026-02-24	DAE4ip Sn1935, 2026-02-18

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 80.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-08-27, 09:37	2026-08-27, 09:44
psSAR1g [W/Kg]	3.67	4.15
psSAR10g [W/Kg]	1.17	1.20
Power Drift [dB]	0.00	-0.06
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only

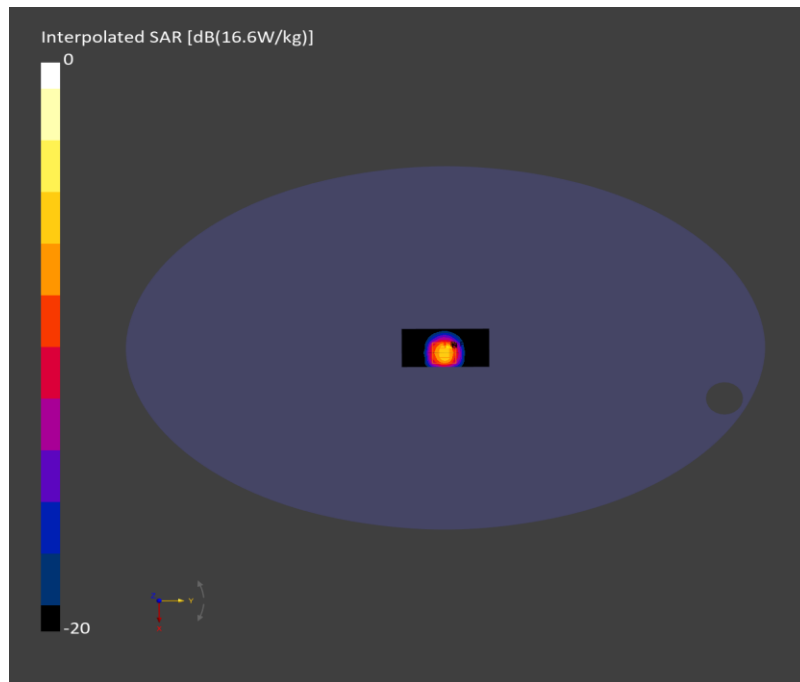


Figure D.14: SAR System performance check for 5200.000 MHz



System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]	Dev. 1g [%]	Dev. 10g [%]	Dev. Peak [%]	Iso. Error [%]
D5GHzV2 - SN1100	5300.0	HSL	17.0	0.6	2.8	5.5	-0.9698632591110701

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	10		CW, 0-	5300.000, 0	5.28	4.69	36.8

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2270	DAK 3.5 Head 18.29 deg.C 2026-Aug-27 SYS4 B8 DAK 3.5 Head 18.29 deg.C 2026-Aug-27 SYS4 B8.prn, 2026-08-27	EX3DV4 - SN7973, 2026-02-24	DAE4ip Sn1935, 2026-02-18

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 80.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-08-27, 09:50	2026-08-27, 09:58
psSAR1g [W/Kg]	3.53	4.04
psSAR10g [W/Kg]	1.12	1.17
Power Drift [dB]	-0.01	-0.00
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only

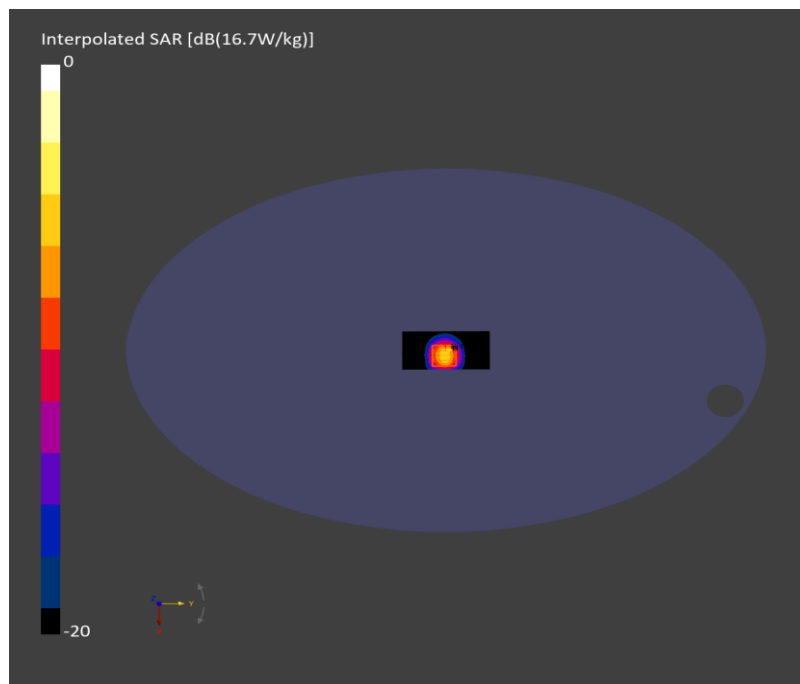


Figure D.15: SAR System performance check for 5300.000 MHz



System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]	Dev. 1g [%]	Dev. 10g [%]	Dev. Peak [%]	Iso. Error [%]
D5GHzV2 - SN1291	5600.0	HSL	17.0	7.3	9.2	11.6	-1.796517235890449

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	10		CW, 0-	5600.000, 0	5.0	5.00	36.7

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2102	HBBL-600-10000 DAK 3.5 Head 19.90 deg.C 2026-Aug-27 SYS3 B11.prm, 2026-08-27	EX3DV4 - SN7804, 2026-08-10	DAE4ip Sn1786, 2026-07-31

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 80.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-08-27, 12:12	2026-08-27, 12:19
psSAR1g [W/kg]	3.49	4.30
psSAR10g [W/kg]	1.15	1.26
Power Drift [dB]	0.03	-0.03
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only

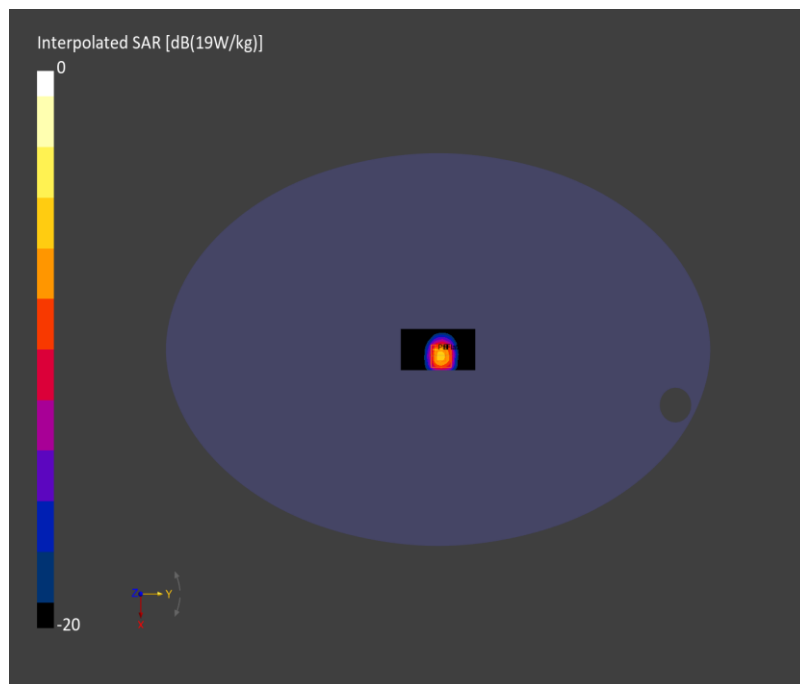


Figure D.16: SAR System performance check for 5600.000 MHz



System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]	Dev. 1g [%]	Dev. 10g [%]	Dev. Peak [%]	Iso. Error [%]
D5GHzV2 - SN1100	5800.0	HSL	17.0	-1.5	4.6	11.2	2.2317340167185895

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	10		CW, 0-	5800.000, 0	4.98	5.13	35.2

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2202	HBBL-600-10000 DAK 3.5 Head 19.08 deg.C 2026-Aug-27 SYS5 B9.prn, 2026-08-27	EX3DV4 - SN3759, 2025-12-04	DAE4ip Sn1785, 2026-02-09

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 80.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-08-27, 10:51	2026-08-27, 10:59
psSAR1g [W/kg]	3.48	4.02
psSAR10g [W/kg]	1.07	1.20
Power Drift [dB]	0.07	0.04
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only

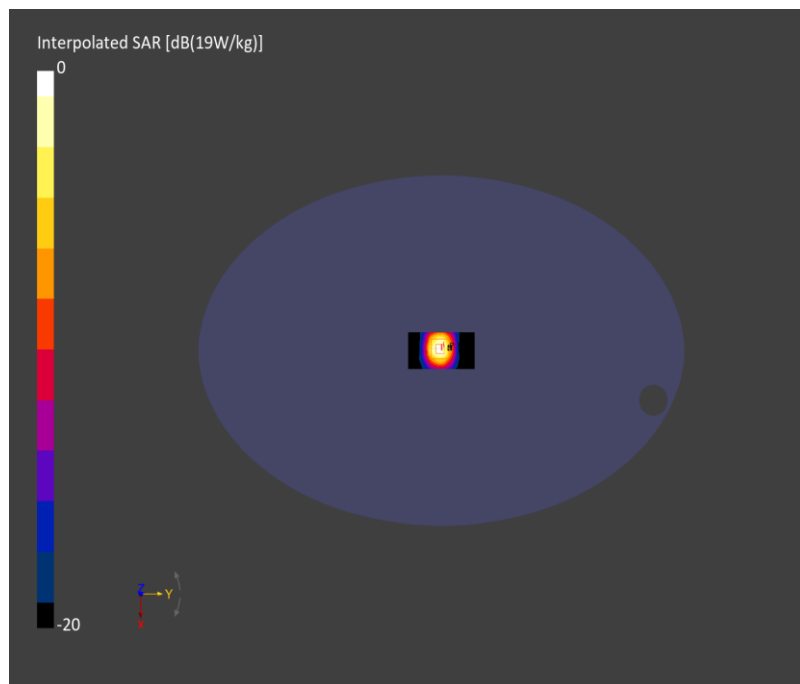


Figure D.17: SAR System performance check for 5800.000 MHz



System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]	Dev. 1g [%]	Dev. 10g [%]	Dev. Peak [%]	Iso. Error [%]
D6.5GHzV2 - SN1071	6500.0	HSL	20.0	-3.0	-0.5	-7.6	1.7514285129828

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	5		CW, 0-	6500.000, 0	5.29	6.00	34.7

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2102	HBBL-600-10000 DAK 3.5 Head 20.12 deg.C 2026-Aug-25 SYS3 B11.prn, 2026-08-25	EX3DV4 - SN7804, 2026-08-10	DAE4ip Sn1786, 2026-07-31

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	51.0 x 85.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	8.5 x 8.5	3.4 x 3.4 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-08-27, 03:11	2026-08-27, 03:22
psSAR1g [W/kg]	22.6	29.5
psSAR10g [W/kg]	5.21	5.63
psAPD (4.0cm2, sq) [W/m2]		136
Power Drift [dB]	-0.11	-0.01
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only

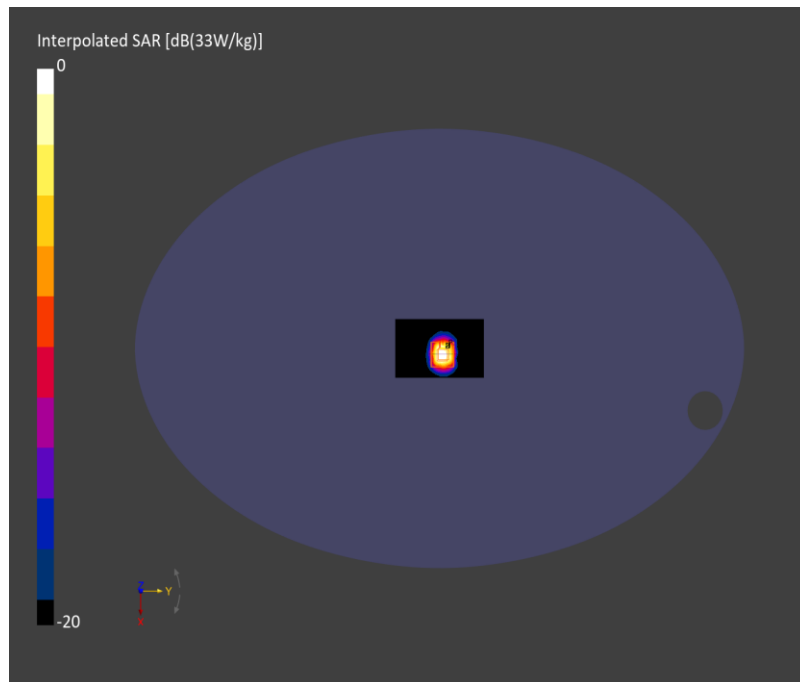


Figure D.18: SAR & APD System performance check for 6500.000 MHz



System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]	Dev. 1g [%]	Dev. 10g [%]	Dev. Peak [%]	Iso. Error [%]
D6.5GHzV2 - SN1071	6500.0	HSL	20.0	2.9	4.6	-3.0	2.1104362261987974

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	5		CW, 0-	6500.000, 0	5.29	5.71	33.1

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2202	HBBL-600-10000 DAK 3.5 Head 19.52 deg.C 2026-Aug-31 SYS5 B9.prn, 2026-08-31	EX3DV4 - SN3759, 2025-12-04	DAE4ip Sn1785, 2026-02-09

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	51.0 x 85.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	8.5 x 8.5	3.4 x 3.4 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-08-31, 10:40	2026-08-31, 10:51
psSAR1g [W/kg]	25.7	31.5
psSAR10g [W/kg]	5.29	5.98
psAPD (4.0cm2, sq) [W/m2]		144
Power Drift [dB]	0.10	-0.02
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only

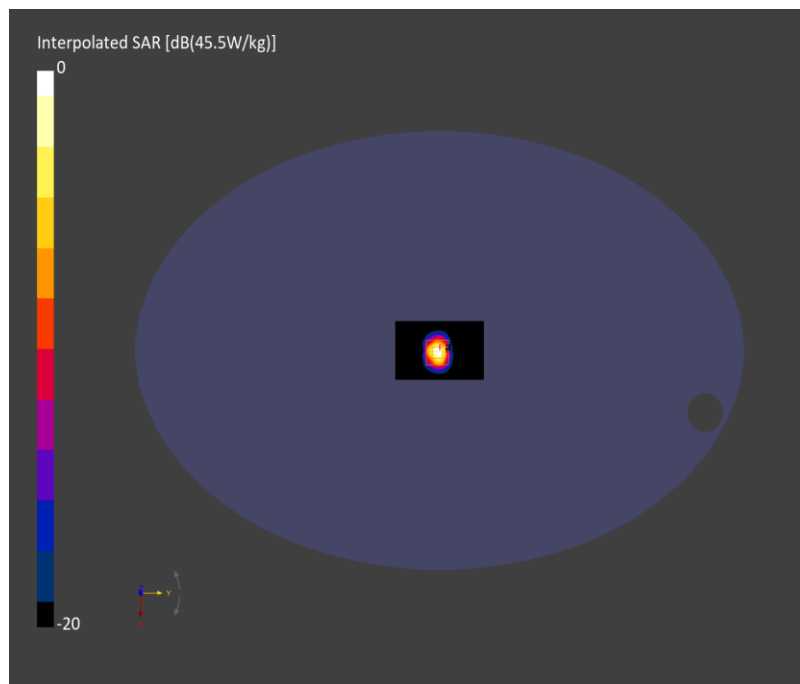


Figure D.19: SAR & APD System performance check for 6500.000 MHz



System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]	Dev. 1g [%]	Dev. 10g [%]	Dev. Peak [%]	Iso. Error [%]
D6.5GHzV2 - SN1071	6500.0	HSL	20.0	-4.2	-2.3	-10.3	1.7435679438743357

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	5		CW, 0-	6500.000, 0	5.26	5.77	33.4

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2203	HBBL-600-10000 DAK 3.5 Head 19.83 deg.C 2026-Aug-31 SYS6 B10.prm, 2026-08-31	EX3DV4 - SN7809, 2026-05-11	DAE4ip Sn1789, 2026-05-08

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	51.0 x 85.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	8.5 x 8.5	3.4 x 3.4 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-08-31, 10:16	2026-08-31, 10:27
psSAR1g [W/kg]	22.6	29.3
psSAR10g [W/kg]	5.10	5.58
Power Drift [dB]	0.06	-0.03
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only

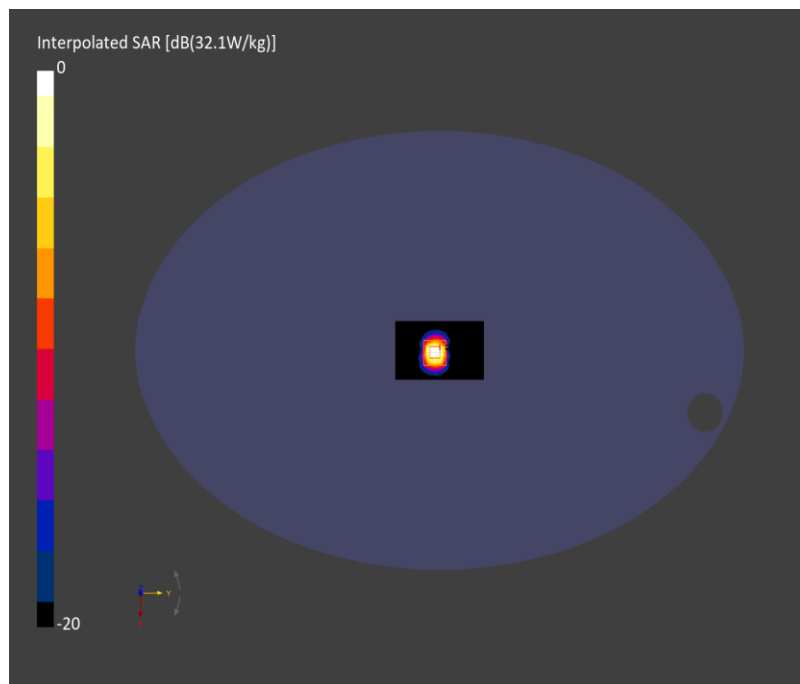


Figure D.20: SAR & APD System performance check for 6500.000 MHz



System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]	Dev. 1g [%]	Dev. 10g [%]	Dev. Peak [%]	Iso. Error [%]
D6.5GHzV2 - SN1071	6500.0	HSL	20.0	-9.5	-6.8	-14.1	2.1838716518181034

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	5		CW, 0-	6500.000, 0	5.32	5.76	33.5

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2270	DAK 3.5 Head 19.8 deg.C 2026-Aug-31 SYS4 B8 , 2026-08-31	EX3DV4 - SN7973, 2026-02-24	DAE4ip Sn1935, 2026-02-18

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	51.0 x 85.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	8.5 x 8.5	3.4 x 3.4 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-09-01, 08:45	2026-09-01, 08:56
psSAR1g [W/kg]	20.5	27.7
psSAR10g [W/kg]	4.68	5.31
psAPD (4.0cm2, sq) [W/m2]		128
Power Drift [dB]	-0.07	0.09
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only

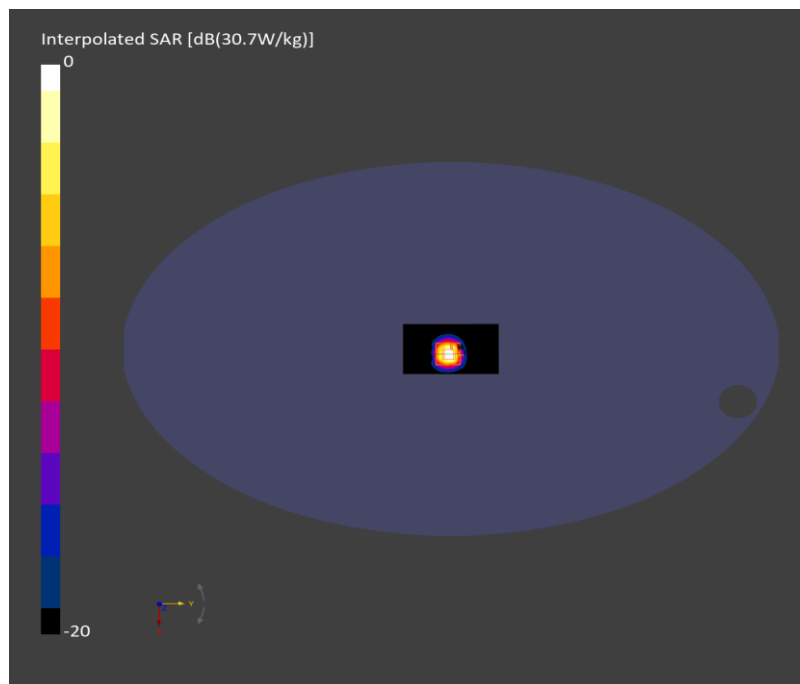


Figure D.21: SAR & APD System performance check for 6500.000 MHz



System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]	Dev. 1g [%]	Dev. 10g [%]	Dev. Peak [%]	Iso. Error [%]
D6.5GHzV2 - SN1071	6500.0	HSL	20.0	-7.0	-4.8	-10.9	2.856317891326232

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	5		CW, 0-	6500.000, 0	5.32	5.81	33.5

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2270	DAK 3.5 Head 19.02 deg.C 2026-Sep-02 SYS4 B8 , 2026-09-02	EX3DV4 - SN7973, 2026-02-24	DAE4ip Sn1935, 2026-02-18

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	51.0 x 85.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	8.5 x 8.5	3.4 x 3.4 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-09-02, 11:07	2026-09-02, 11:18
psSAR1g [W/kg]	20.4	28.4
psSAR10g [W/kg]	4.87	5.43
psAPD (4.0cm2, sq) [W/m2]		131
Power Drift [dB]	0.05	-0.11
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only

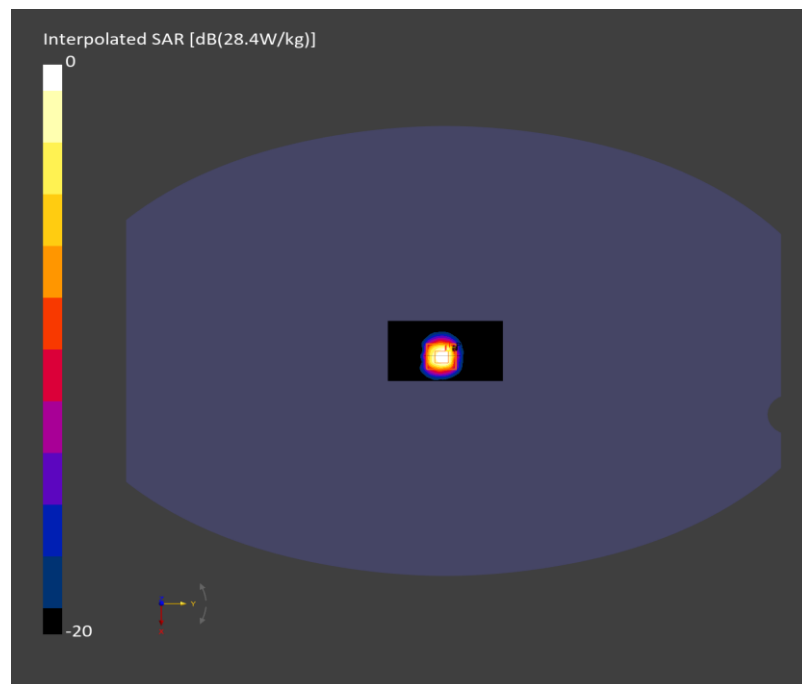


Figure D.22: SAR & APD System performance check for 6500.000 MHz



System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]	Dev. 1g [%]	Dev. 10g [%]	Dev. Peak [%]	Iso. Error [%]
D2450V2 - SN715	2450.0	HSL	17.0	2.1	3.1	-4.3	-0.7426822408303502

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	10		CW, 0-	2450.000, 0	6.9	1.67	40.8

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2202	HBBL-600-10000 DAK 3.5 Head 20.13 deg.C 2026-Sep-04 SYS5 B9.prn, 2026-09-04	EX3DV4 - SN3759, 2025-12-04	DAE4ip Sn1785, 2026-02-09

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 80.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-09-05, 09:26	2026-09-05, 09:33
psSAR1g [W/Kg]	2.71	2.67
psSAR10g [W/Kg]	1.25	1.26
Power Drift [dB]	-0.03	-0.05
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only

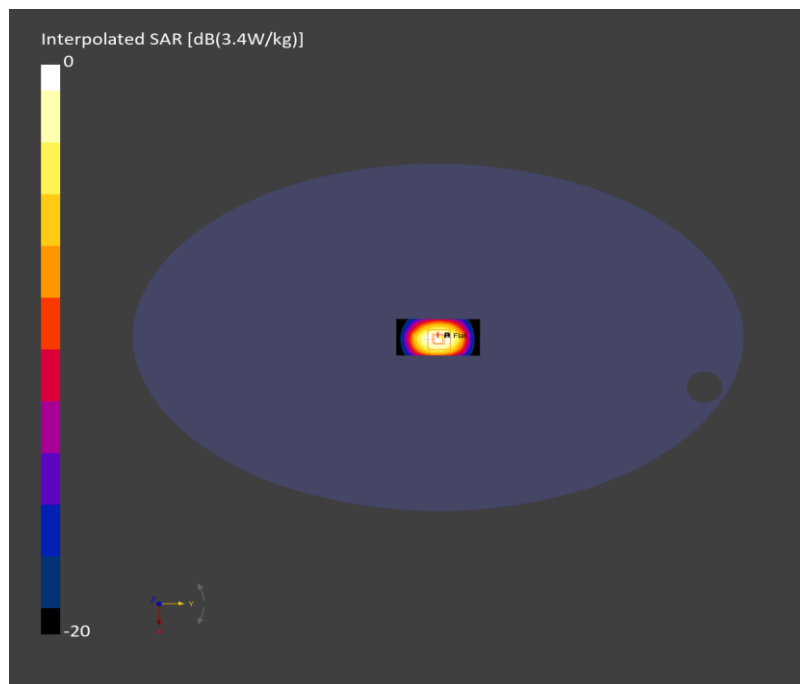


Figure D.23: SAR System performance check for 2450.000 MHz



System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]	Dev. 1g [%]	Dev. 10g [%]	Dev. Peak [%]	Iso. Error [%]
D2450V2 - SN715	2450.0	HSL	17.0	-8.9	-7.5	-14.6	0.7

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	10		CW, 0--	2450.000, 0	7.54	1.69	39.7

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2102	HBBL-600-10000 DAK 3.5 Head 20.13 deg.C 2026-Sep-06 SYS3 B11, 2026-09-06	EX3DV4 - SN7804, 2026-08-10	DAE4ip Sn1786, 2026-07-31

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 80.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-09-07, 09:22	2026-09-07, 09:30
psSAR1g [W/kg]	2.35	2.38
psSAR10g [W/kg]	1.10	1.13
Power Drift [dB]	0.01	-0.00
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only

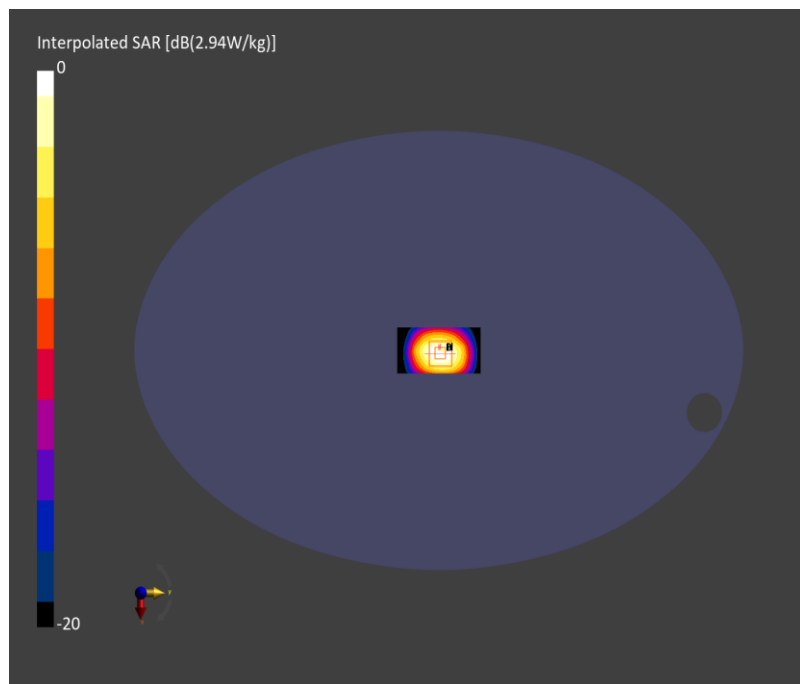


Figure D.24: SAR System performance check for 2450.000 MHz



System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]	Dev. 1g [%]	Dev. 10g [%]	Dev. Peak [%]	Iso. Error [%]
D5GHzV2 - SN1100	5200.0	HSL	17.0	-3.4	-3.0	-3.8	-1.0904303582600305

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	10		CW, 0-	5200.000, 0	5.79	4.24	35.2

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2203	HBBL-600-10000 DAK 3.5 Head 19.66 deg.C 2026-Sep-06 SYS6 B10.prm, 2026-09-06	EX3DV4 - SN7809, 2026-05-11	DAE4ip Sn1789, 2026-05-08

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 80.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-09-07, 08:27	2026-09-07, 08:34
psSAR1g [W/kg]	3.45	3.79
psSAR10g [W/kg]	1.05	1.09
Power Drift [dB]	0.02	-0.02
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only

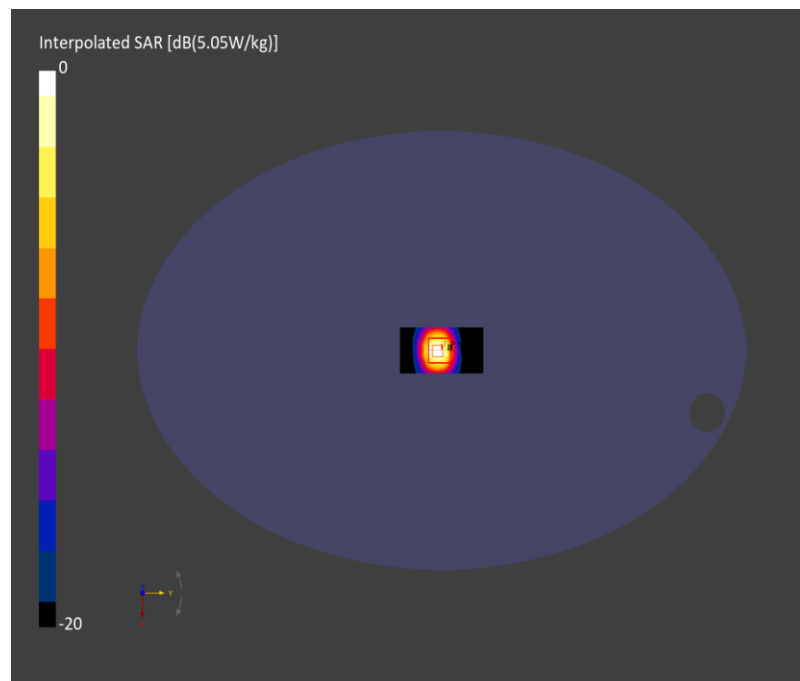


Figure D.25: SAR System performance check for 5200.000 MHz



System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]	Dev. 1g [%]	Dev. 10g [%]	Dev. Peak [%]	Iso. Error [%]
D5GHzV2 - SN1100	5800.0	HSL	17.0	1.9	2.3	11.2	0.7294707673436651

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	10		CW, 0-	5800.000, 0	5.06	4.89	34.2

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2203	HBBL-600-10000 DAK 3.5 Head 19.66 deg.C 2026-Sep-06 SYS6 B10.prm, 2026-09-06	EX3DV4 - SN7809, 2026-05-11	DAE4ip Sn1789, 2026-05-08

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 80.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-09-07, 08:58	2026-09-07, 09:05
psSAR1g [W/kg]	3.75	4.19
psSAR10g [W/kg]	1.12	1.18
Power Drift [dB]	0.01	0.01
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only

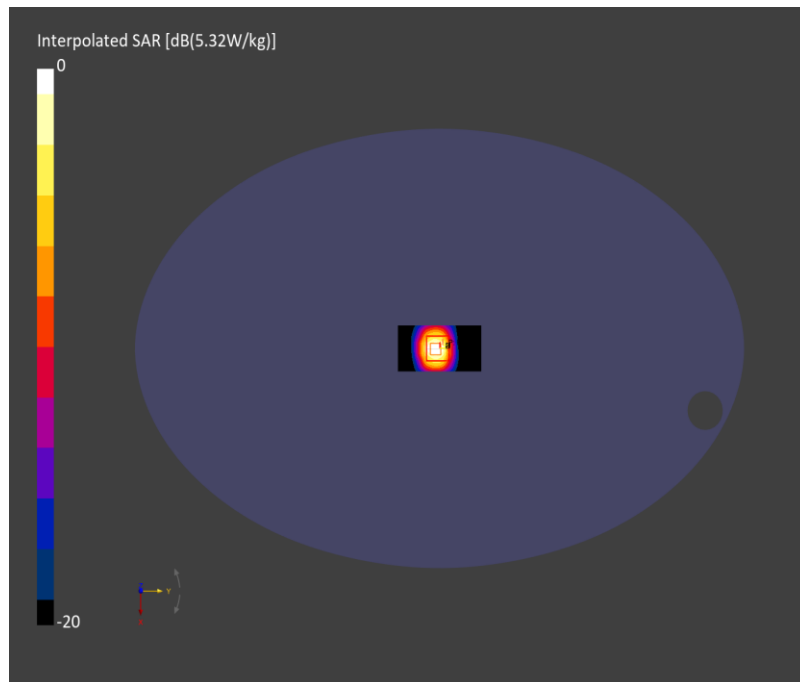


Figure D.26: SAR System performance check for 5800.000 MHz



System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]	Dev. 1g [%]	Dev. 10g [%]	Dev. Peak [%]	Iso. Error [%]
D2450V2 - SN715	2450.0	HSL	17.0	-0.4	-0.4	-5.5	0.6

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	10		CW, 0--	2450.000, 0	7.54	1.69	40.6

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2102	HBBL-600-10000 DAK 3.5 Head 21.12 deg.C 2026-Sep-08 SYS3 B11.prm, 2026-09-08	EX3DV4 - SN7804, 2026-08-10	DAE4ip Sn1786, 2026-07-31

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	40.0 x 80.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-09-08, 13:14	2026-09-08, 13:21
psSAR1g [W/kg]	2.50	2.61
psSAR10g [W/kg]	1.19	1.22
Power Drift [dB]	-0.00	-0.02
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only

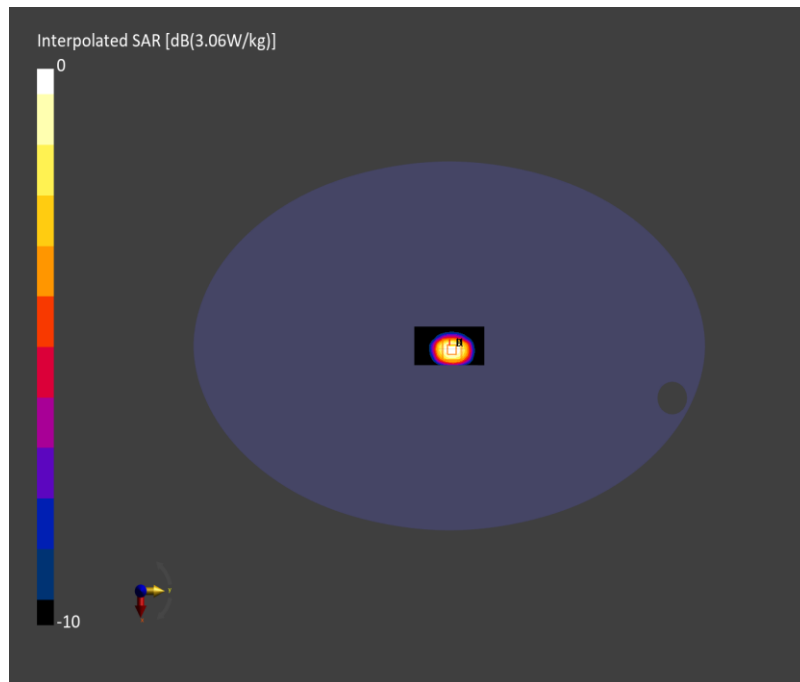


Figure D.27: SAR System performance check for 2450.000 MHz



System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]	Dev. 1g [%]	Dev. 10g [%]	Dev. Peak [%]	Iso. Error [%]
D6.5GHzV2 - SN1071	6500.0	HSL	20.0	-9.5	-8.3	-15.5	2.1579163648433486

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, Head Simulating Liquid	5		CW, 0-	6500.000, 0	5.32	5.75	34.4

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
ELI V8.0 (20deg probe tilt) - 2270	DAK 3.5 Head ELI 20.22 deg.C 2026-Sep-16 SYS4 B8 DAK 3.5 Head ELI 20.22 deg.C 2026-Sep-16 SYS4 B8.prn, 2026-09-16	EX3DV4 - SN7973, 2026-02-24	DAE4ip Sn1935, 2026-02-18

Scans Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	51.0 x 85.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	8.5 x 8.5	3.4 x 3.4 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2026-09-16, 17:26	2026-09-16, 17:36
psSAR1g [W/kg]	20.7	27.5
psSAR10g [W/kg]	4.48	5.19
psAPD (4.0cm2, sq) [W/m2]		125
Power Drift [dB]	0.01	0.02
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	Positive only	Positive only

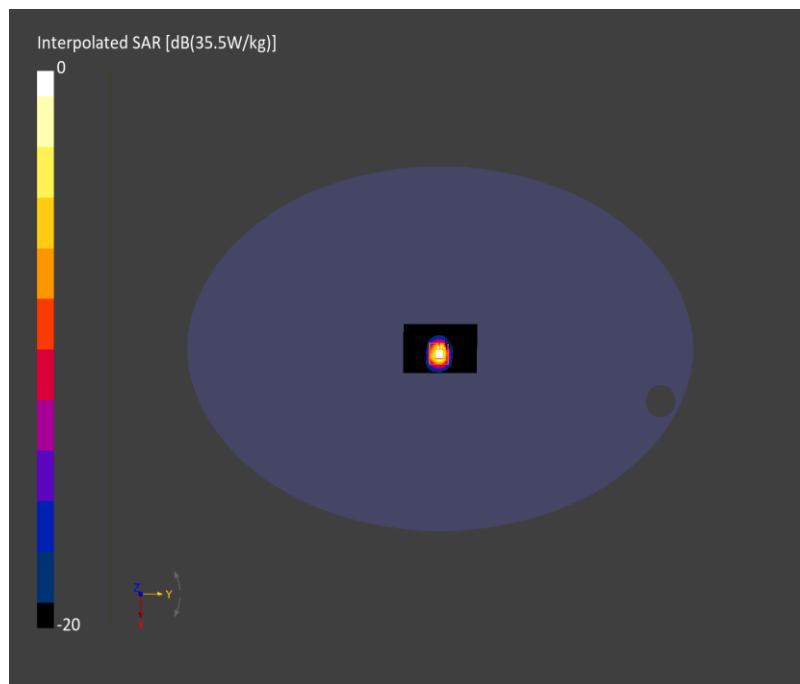


Figure D.28: SAR and APD System performance check for 6500.000 MHz



Measurement Report for 10 GHz Horn antenna, FRONT, Custom Band, CW, Channel 10000000 (10000.0 MHz)

Device Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
10 GHz Horn antenna,	100.0 x 100.0 x 172.0		Horn

Exposure Conditions

Phantom Section	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor
5G	FRONT, 10.00	Custom Band	CW, 0--	10000.0, 10000000	1.0

Hardware Setup

Phantom	Medium	Probe, Calibration Date	DAE, Calibration Date
mmWave - 1112	Air -	EUmmWV4 - SN9609_F1-55GHz, 2025-09-09	DAE4 Sn475, 2025-11-26

Scans Setup

Scan Type	5G Scan
Grid Extents [mm]	80.0 x 60.0
Grid Steps [lambda]	0.125 x 0.125
Sensor Surface [mm]	10.0
MAIA	Y

Measurement Results

Scan Type	5G Scan
Date	2026-09-17, 04:03
Avg. Area [cm ²]	4.00
psPDn+ [W/m ²]	53.5
psPDtot+ [W/m ²]	53.8
psPDmod+ [W/m ²]	54.0
E _{max} [V/m]	149
Power Drift [dB]	-0.03

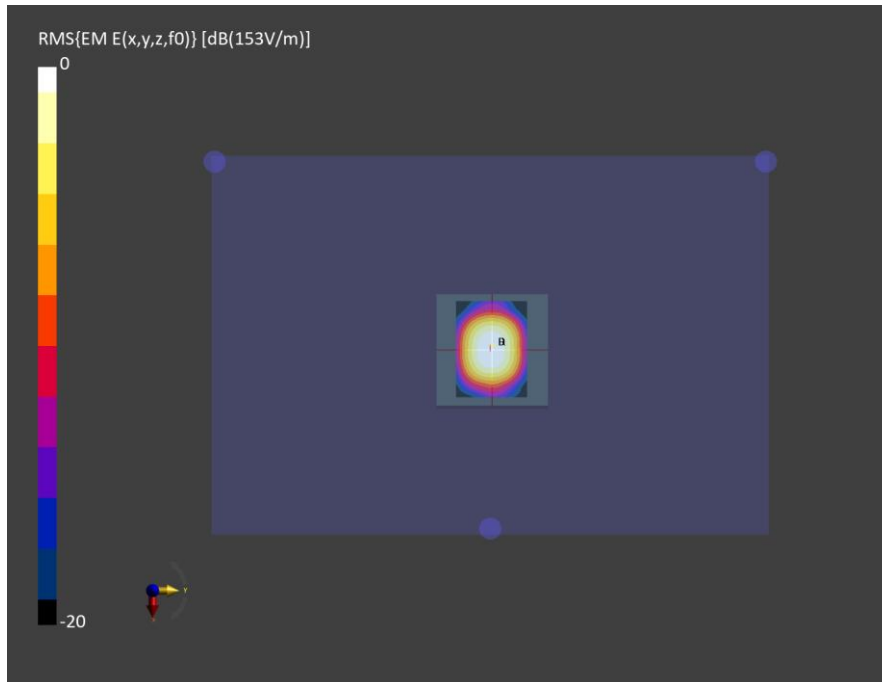


Figure D.29: iPD System performance check for 6500.000 MHz